

EMC Design Issues for Power Electronics Converters



Ilknur Colak

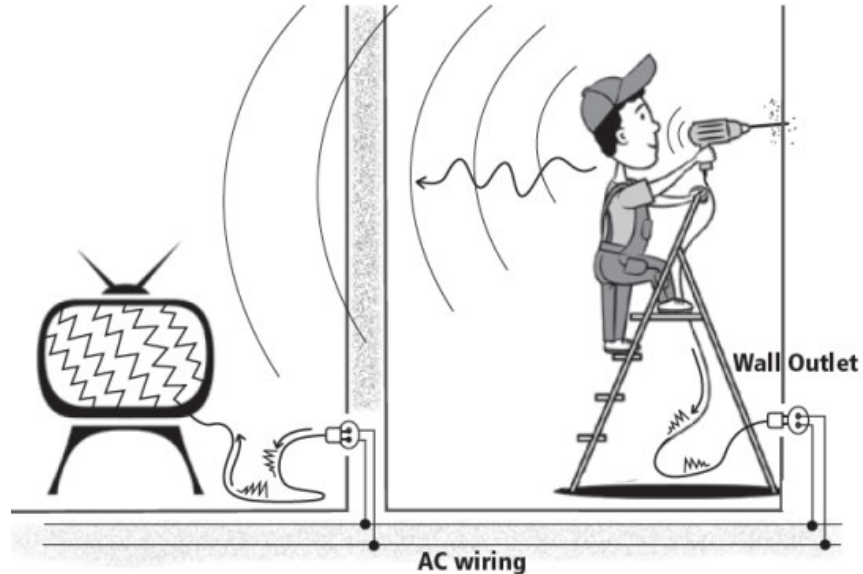
Maschinenfabrik Reinhausen

OUTLINE

- Introduction
- Overview on Electromagnetic Basics
- Coupling Mechanisms
- Design Process
- Standards and Regulations
- Summary

$$E \propto I \cdot f^2 \cdot A \cdot \frac{1}{r}$$

r = distance
I = current
A = loop area
f = frequency



INTRODUCTION

OUTLINE

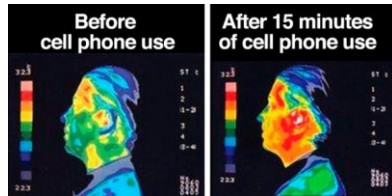
- **Introduction**
- Overview on Electromagnetic Basics
- Coupling Mechanisms
- Design Process
- Standards and Regulations
- Summary

Importance of EMC

- ◆ Practical impact can be **minor** annoyance to **lethal** ...and everything in between;
 - Loss of life, property or system
 - Injury, damage to system, loss of operation
 - Annoyance, nuisance, temporary loss of performance
 - Product may be blocked from the market

Problems with Non-Compliance

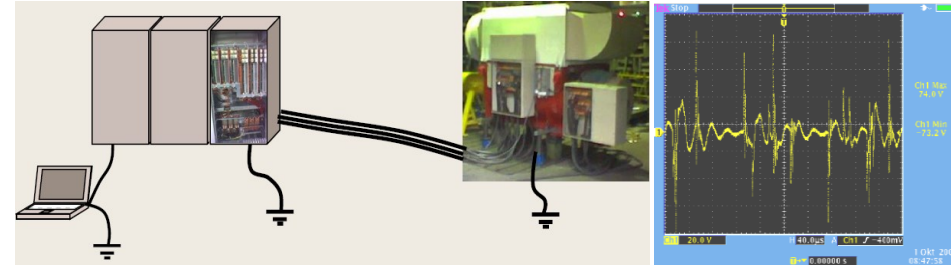
Annoyance, Delays	Lost Revenue, Minor Property Loss	Significant Property Loss	Death or Serious Injury
Minor		Major	
<ul style="list-style-type: none">•AM/FM/XM/TV Interference•Cell Phone Interference	<ul style="list-style-type: none">•Critical communications Interference/Interruption•Automated Monetary Transactions		<ul style="list-style-type: none">•RADAR, Landing System Interruption•Erroneous Ordnance Firing•Improper Deployment of Airbags



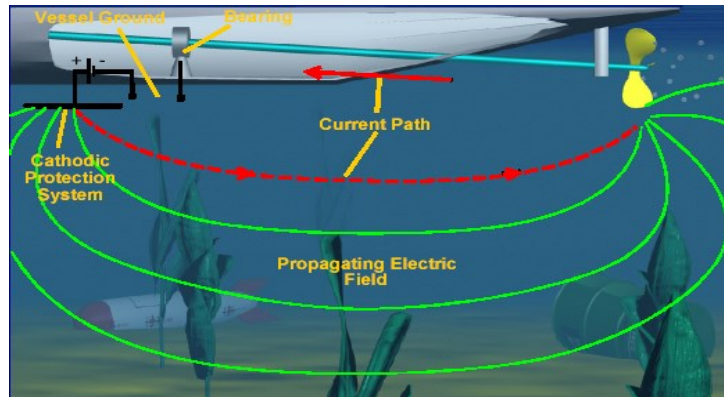
EMC Problems

Failing to meet requirements, most common cause is radiated emission.

Ex. 1. Start up of a wind turbine inverter.
The power supply of the converter blew up.
Grounding potential of inverter bounces.
Current via the shield exceed the limits of the computer



Ex. 2. The magnetic field of the ships triggers the torpedo and cause explosion



EMC Problems

Ex. 3. Brazil rocket explosion (2003) -

Alcantara launch center

21 people killed

20 more injured

Reason: EMI triggered one of the rocket's four solid fuel boosters



Ex. 4. Aircraft carrier explosion (1967) -

Vietnam

134 sailors killed

161 injured

Reason: Due to EMI a rocket on the flight deck was discharged



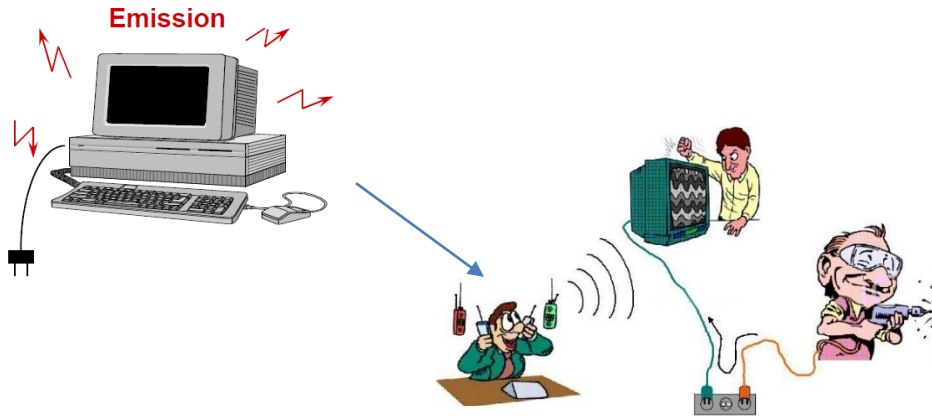
OVERVIEW ON ELECTROMAGNETIC BASICS

Outline

- Introduction
- Overview on Electromagnetic Basics
- Coupling Mechanisms
- Design Process
- Standards and Regulations
- Summary

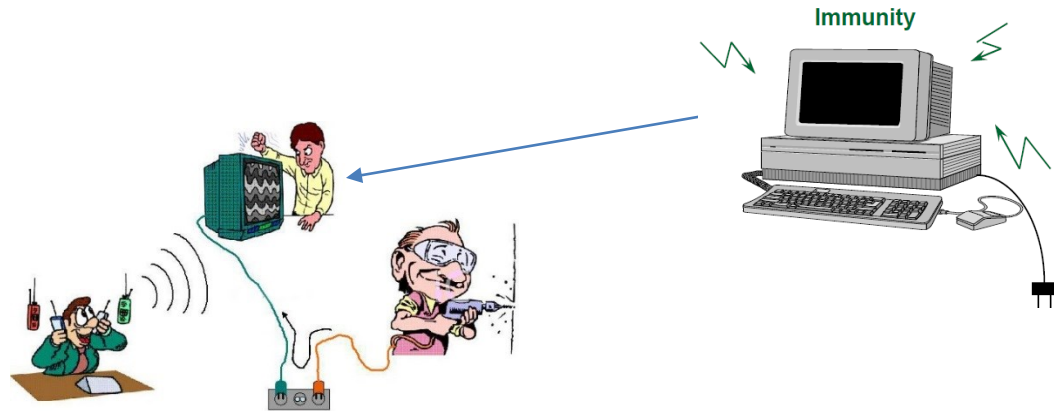
Emission

- The manufacturers are obliged to ensure that the electrical devices produce very little electromagnetic disturbances (within the limits) to their surroundings.



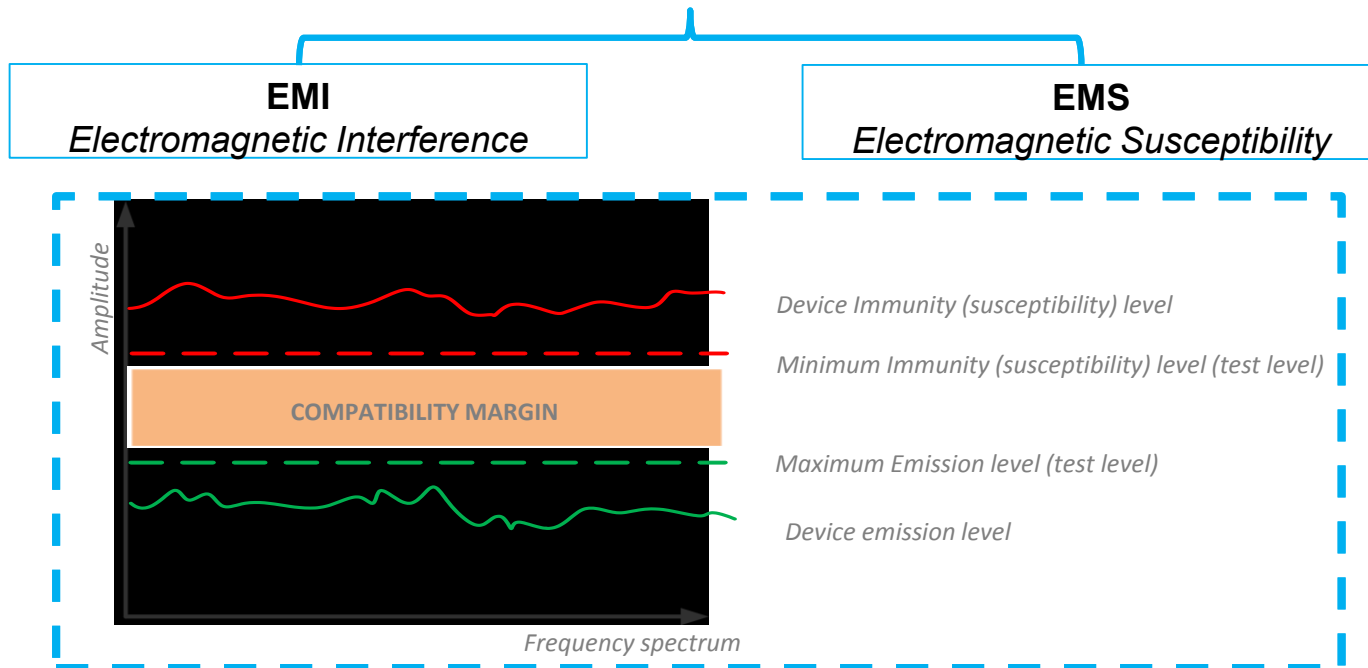
Immunity

- Electrical device manufacturers are obliged to protect their devices from electromagnetic disturbances.



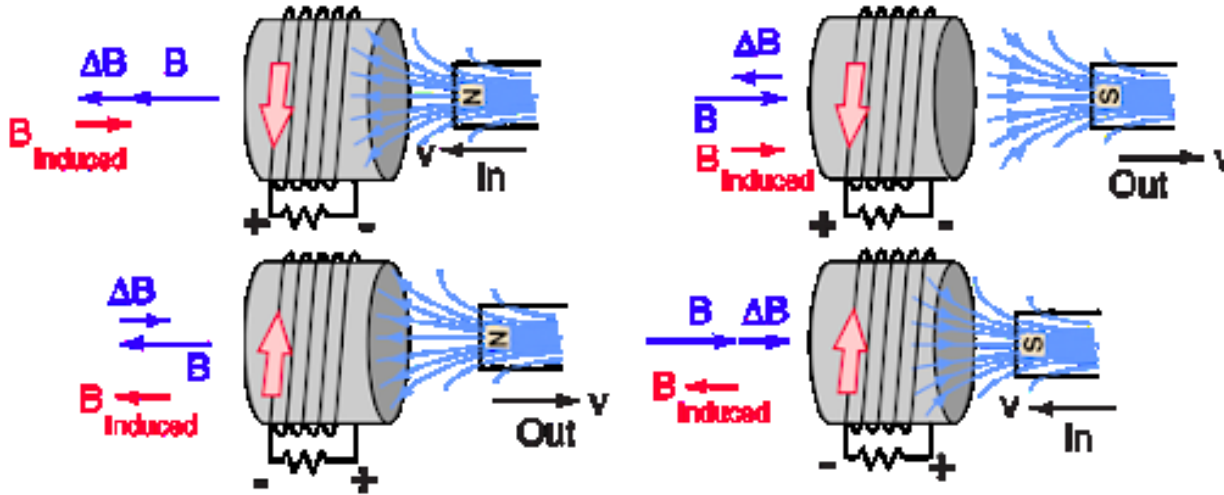
EMC

- Does NOT cause interferences with itself and other systems
- Is NOT susceptible to emissions from other systems



Electromagnetic Wave Basics

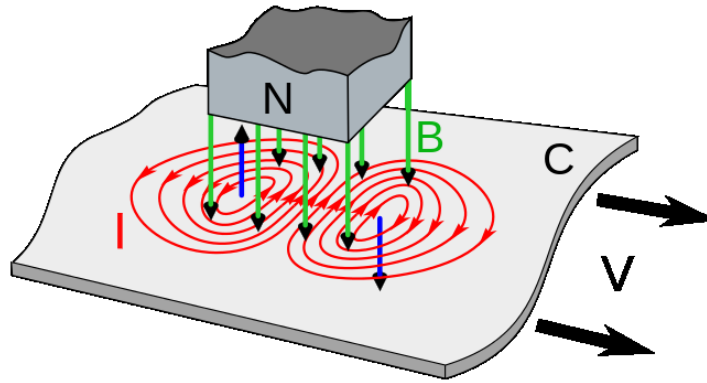
A changing magnetic field induces an emf and therefore an electric field.



$$\oint \vec{E} \cdot d\vec{l} = -\frac{d\Phi_B}{dt}$$

Electromagnetic Wave Basics

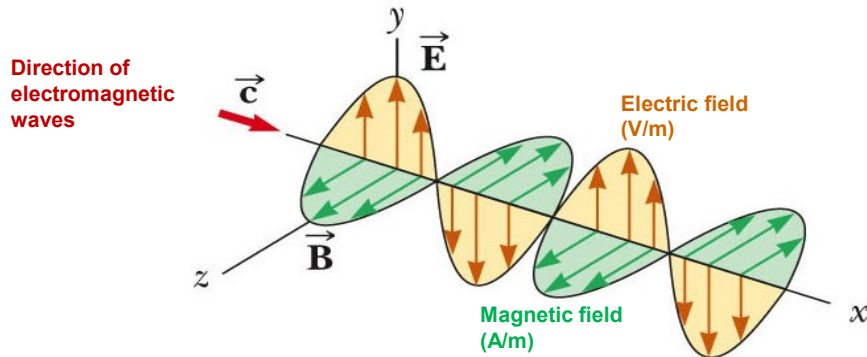
A changing electric field produces magnetic field.



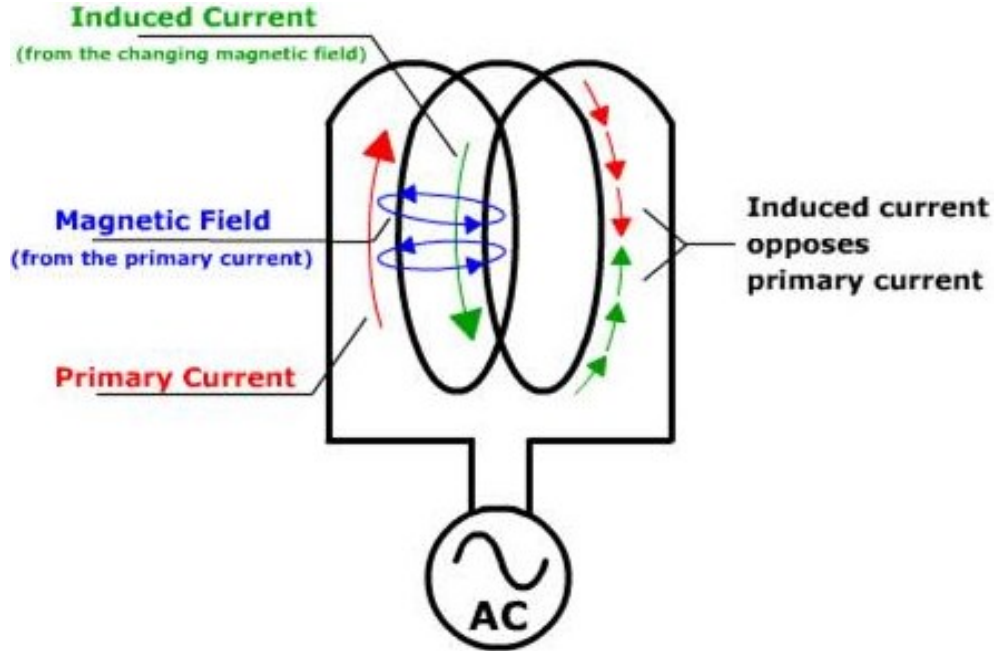
$$\oint \vec{B} \cdot d\vec{l} = \mu_0 I + \mu_0 \epsilon_0 \frac{d\Phi_E}{dt}$$

Electromagnetic Wave Basics

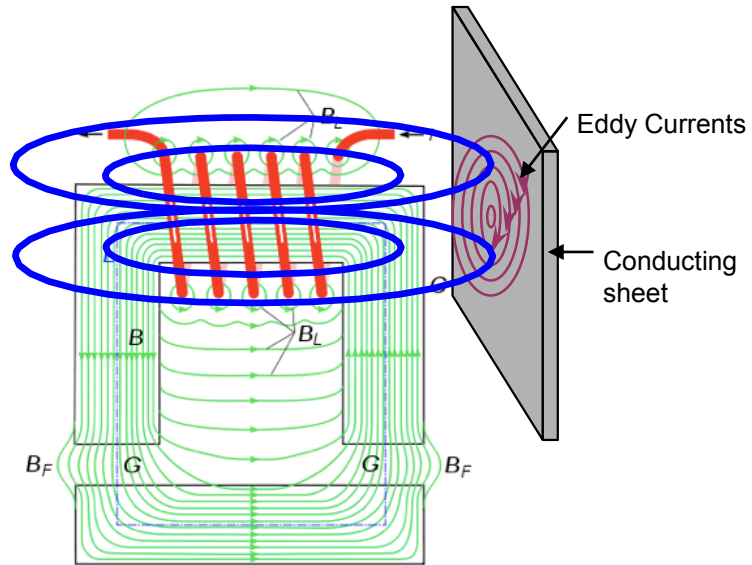
An electromagnetic wave consists of combination of a transverse electric field and a transverse magnetic field perpendicular to each other.



$$E = cB$$

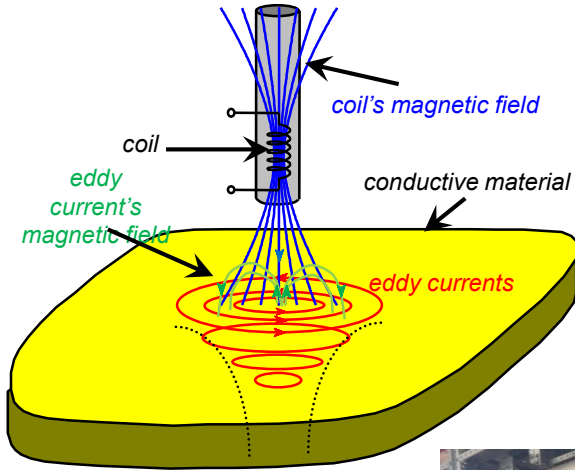


Eddy Currents



- Eddy currents are created through electromagnetic induction.
- They are induced electrical currents that flow in a circular path.

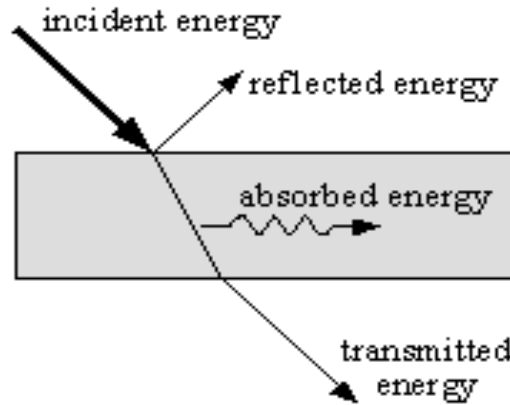
Eddy Currents



- Eddy currents flowing in the material will generate their own “secondary” magnetic field which will oppose the coil’s “primary” magnetic field.
- Eddy currents are **strongest** at the surface of the material and decrease in strength below the surface.
- Thicker materials will support more eddy currents than thinner materials.
- The depth that the eddy currents are only 37% as strong as they are on the surface is known as the standard depth of penetration or skin depth. The depth changes with;
 - frequency
 - material conductivity
 - permeability.



Shielding



- When radiation strikes a surface, a portion of it is reflected, and the rest enters the surface.
- When radiation enters the surface, some are **absorbed** by the material, and the remaining radiation is transmitted through.
- The ratio of **reflected** energy to the incident energy is called reflectivity, ρ .
- Transmissivity (τ) is defined as the fraction of the incident energy that is **transmitted** through the object.

$$R + A + T = 1$$

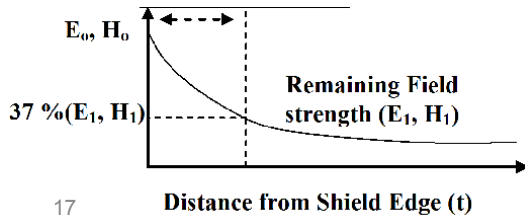
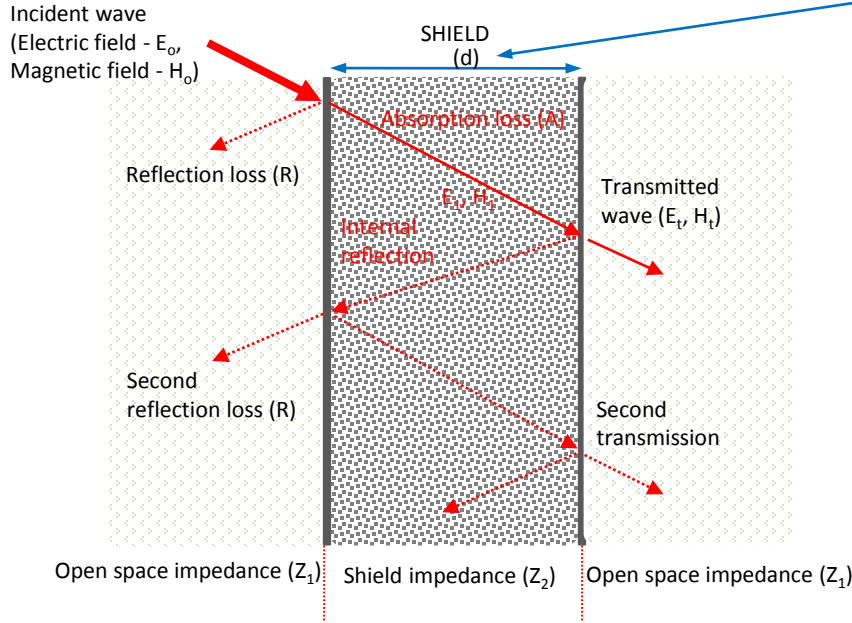
Shielding effectiveness (SE) = R + A + B

R: Reflective losses

A: Absorption losses

B: Secondary reflective losses (ignore if A > 8 dB)

Shielding



Required thickness for shielding magnetic field:

$$d = \sqrt{\frac{2}{\omega K \mu}}$$

d = thickness of shield material

K = conductivity of shield material

μ = permeability of shield material

ex: at 150kHz, 0.1mm copper sheet will have a good shielding effect

$$\text{Open shield impedance} \rightarrow Z_1 = \sqrt{\frac{\mu_0}{\epsilon_0}} = 120\pi = 377[\Omega]$$

$$\text{Shield intrinsic impedance} \rightarrow Z_2 = \sqrt{\frac{j\omega\mu}{\sigma + j\omega\epsilon}} [\Omega]$$

$$\text{Reflection losses} \rightarrow R = 20 \cdot \log_{10} \left| \frac{(Z_1 + Z_2)^2}{4 \cdot Z_1 \cdot Z_2} \right| [\text{dB}]$$

$$\text{Internal electric field} \rightarrow E_1 = \frac{2 \cdot Z_2}{Z_1 + Z_2} \cdot E_o$$

$$\text{Internal magnetic field} \rightarrow H_1 = \frac{2 \cdot Z_1}{Z_1 + Z_2} \cdot H_o$$

$$\text{Transmitted electric field} \rightarrow E_t = \frac{2 \cdot Z_1}{Z_1 + Z_2} \cdot E_1$$

$$\text{Transmitted magnetic field} \rightarrow H_t = \frac{2 \cdot Z_2}{Z_1 + Z_2} \cdot H_1$$

Self Inductance of a Cable

- The self inductance of a solid round conductor: $L = K_u \cdot l \cdot \left[\log_e \left(\frac{2 \cdot l}{r} \right) - \frac{3}{4} \right]$

$$X_L = 2\pi f L$$

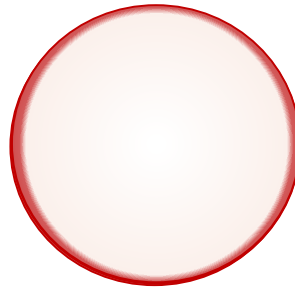
- A conductor is useless if $L > \frac{10}{f(\text{MHz})}$ (ex: pigtail)



Skin Effect

Resistance of a cable with AC current: $R_{ac} = R_{dc} * (1 + Y_s + Y_p)$

Y_s due to skin effect



$f = 50 \text{ Hz}$

Single conductor carrying AC current

Skin Effect

Resistance of a cable with AC current: $R_{ac} = R_{dc} * (1 + Y_s + Y_p)$

due to skin effect

How to reduce skin effect:

- Segmenting the conductors
- Making hollow core conductors
- Metal coating for individual wire strands

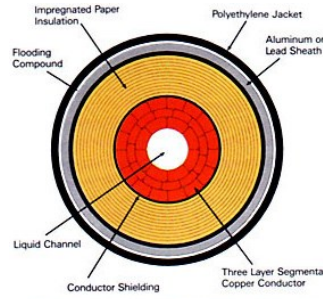
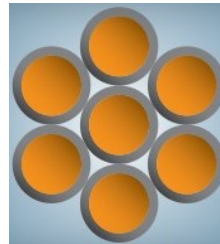
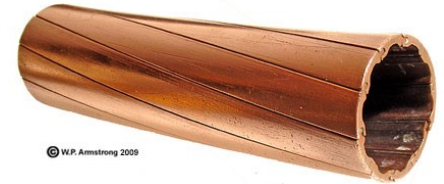


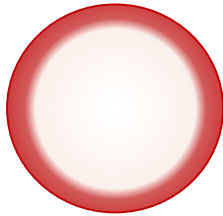
Figure 1: Copper Segmental Conductor



Proximity Effect

Resistance of a cable with AC current: $R_{ac} = R_{dc} * (1 + Y_s + Y_p)$

due to proximity effect



Single conductor carrying AC current

How to reduce proximity effect:

In most cases if conductor spacing exceeds 10 times the conductor diameter proximity effect can be less than 1% and can be neglected.

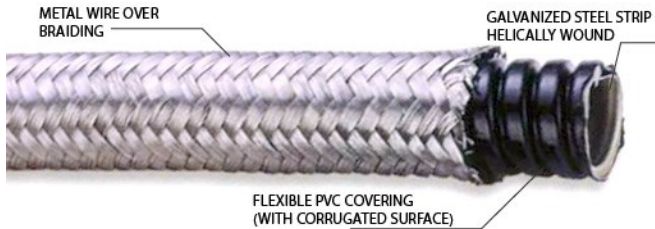
Proximity effect
Conductors carrying current in the opposite direction

Proximity effect
Conductors carrying current in the same direction

Magnetic Conduit & Length Effect

Resistance of a cable with AC current: $R_{ac} = R_{dc} * (1 + (Y_s + Y_p) * 1.7)$

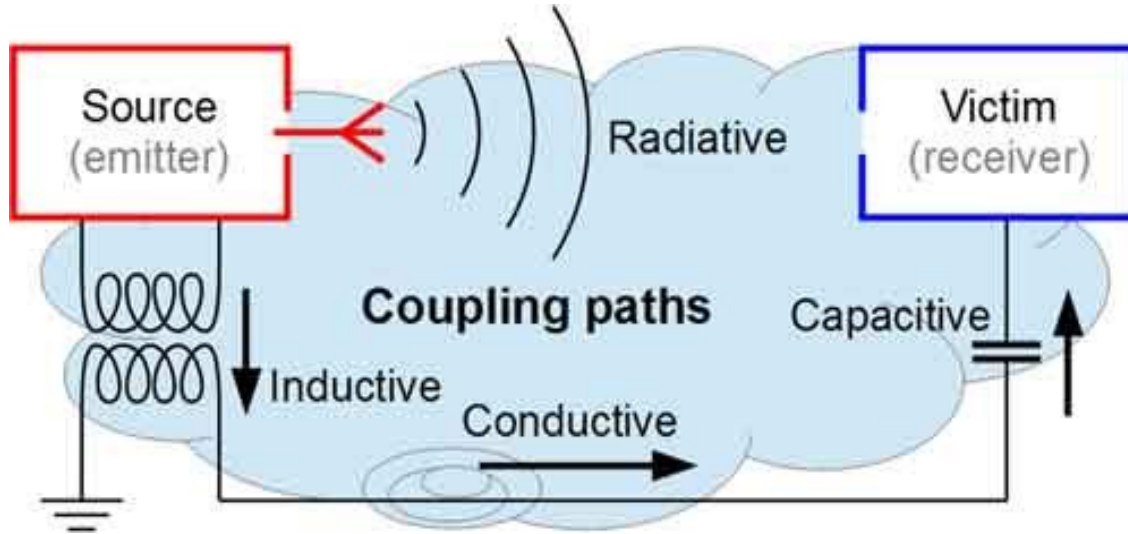
due to magnetic conduit effect



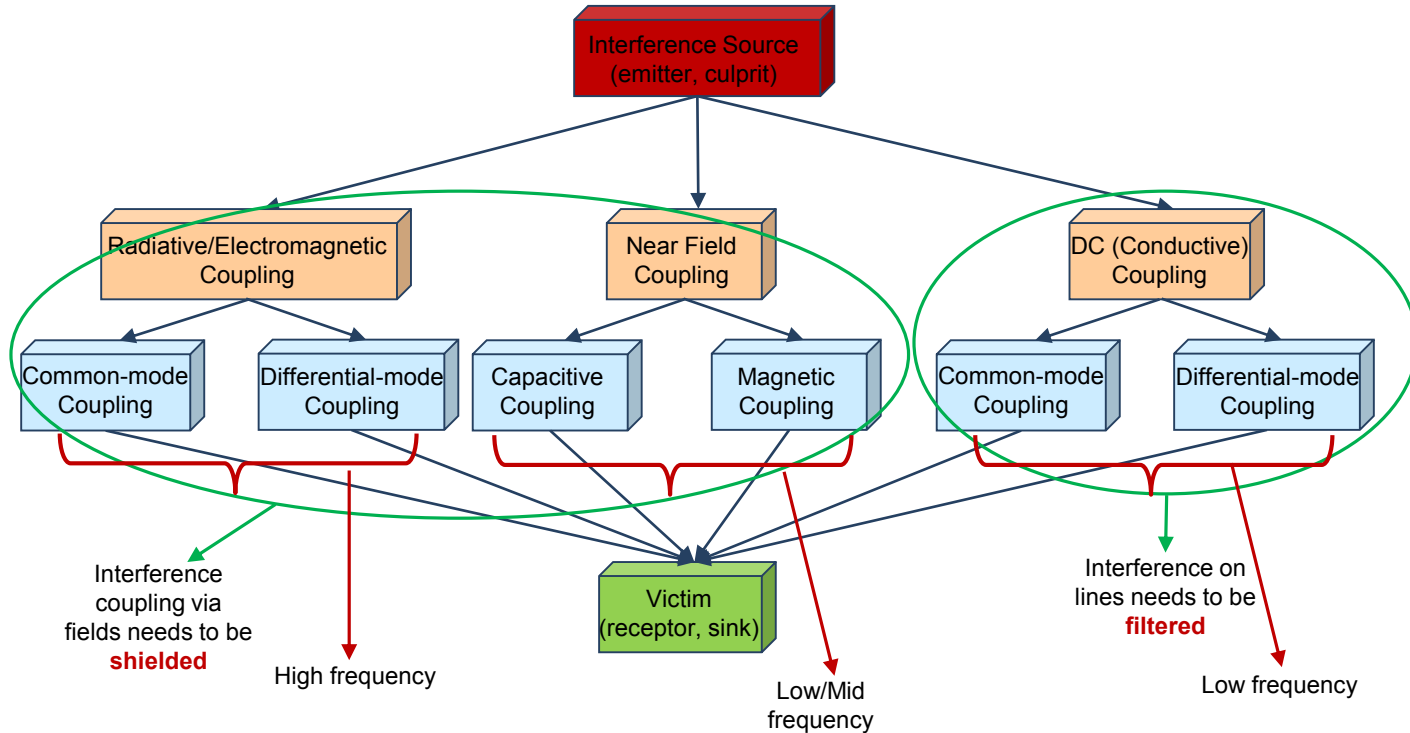
- Operation over long cables introduces distortion and noise which affect frequency response of the cable.
- For signals $f < 10$ kHz distortion generally is not a problem.
- If $f > 10$ kHz, signal distortion may occur over cables longer than 30 meters.

Coupling Mechanisms

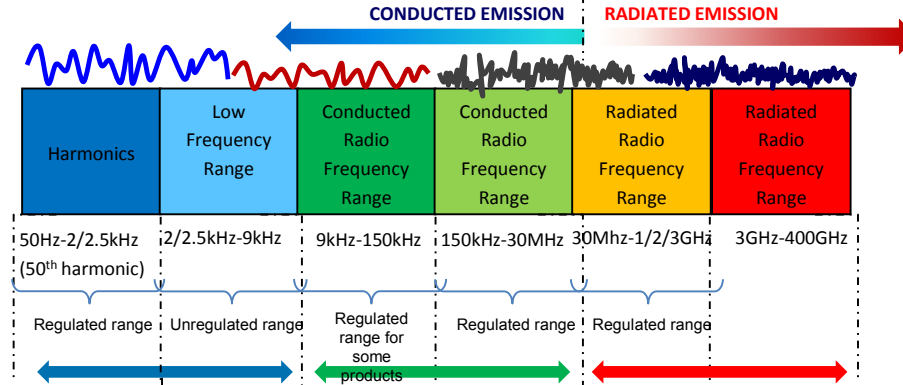
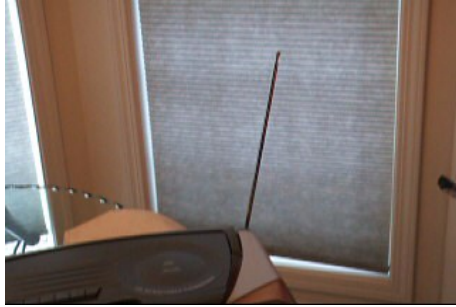
Shielding or Filtering?



Coupling Mechanisms



Electromagnetic Spectrum



Conducted Low Frequency Phenomena:

- Harmonics, interharmonics
- Signalling voltages
- Voltage fluctuations
- Voltage dips and interruptions
- Voltage unbalance
- Power-frequency variations
- Induced low-frequency voltages
- DC in AC networks

Radiated Low Frequency Phenomena:

- Magnetic fields
- Electric fields

Conducted High Frequency Phenomena (RF):

- Induced continuous-wave voltages or currents
- Unidirectional transients
- Oscillatory transients

Radiated High Frequency Phenomena:

- Magnetic fields
- Electric fields
- Electromagnetic fields
 - continuous waves
 - transients

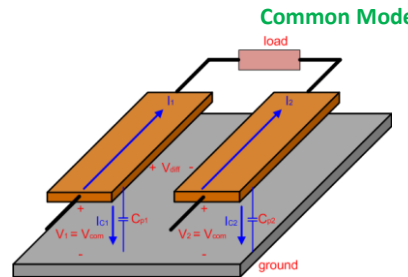
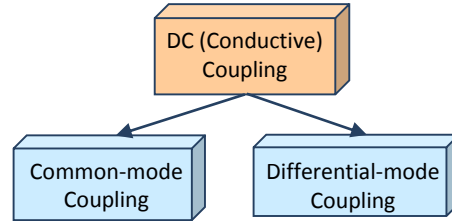
COUPLING MECHANISMS

Outline

- Introduction
- Overview on Electromagnetic Basics
- **Coupling Mechanisms**
- Design Process
- Standards and Regulations
- Summary

Direct Coupling

- Conductive coupling occurs when the coupling path is formed by direct electrical contact.

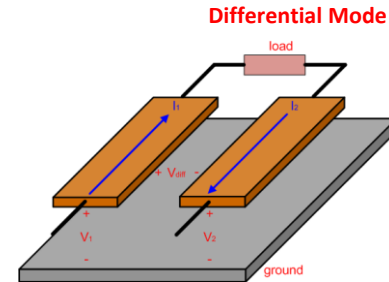


Disturbance flows via the phase/neutral line to the receiver and via ground back to the source.

$$V_1 = V_{\text{com}1} \neq 0$$
$$V_2 = V_{\text{com}2} \neq 0$$

Pure common mode occurs when;

$$V_1 = V_2 = V_{\text{com}}$$
$$V_1 - V_2 = 0$$



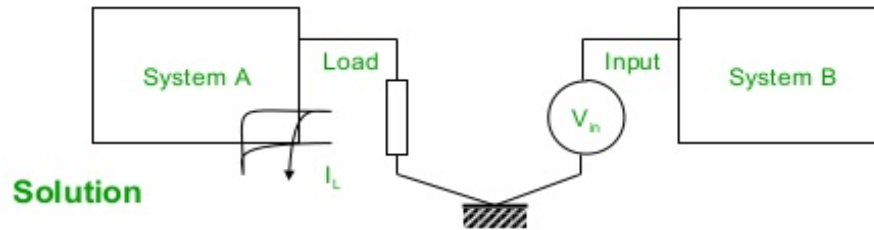
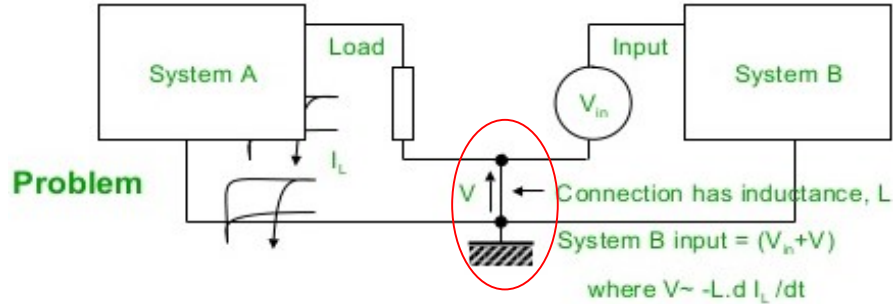
Disturbance flows via the phase line to the receiver and via the neutral line back to the source.

$$V_{\text{diff}} = V_1 - V_2 \neq 0$$

Pure differential mode occurs when;

$$V_1 = -V_2$$

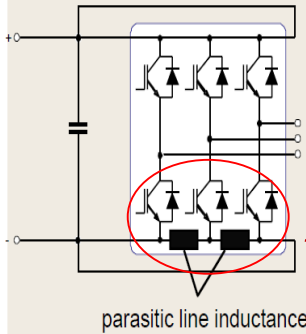
Direct Coupling



Common mode impedance coupling

Direct Coupling

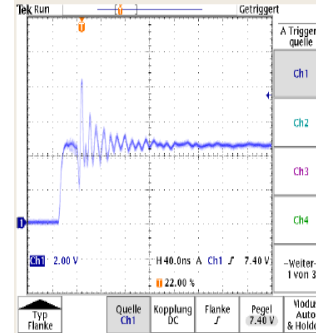
Example: Increased losses of an semiconductor module



Results

The semiconductors show a behavior as expected, but: three low side IGBT are DC coupled. The lines show a inductance in the range of several nH. The current changes in these lines reach amplitudes in the range of kA/ μ s and generate voltage drops of several volts. Thereby logic signals are disturbed and generate undesired switching on.

Example: Increased losses of an semiconductor module



Disturbed signal

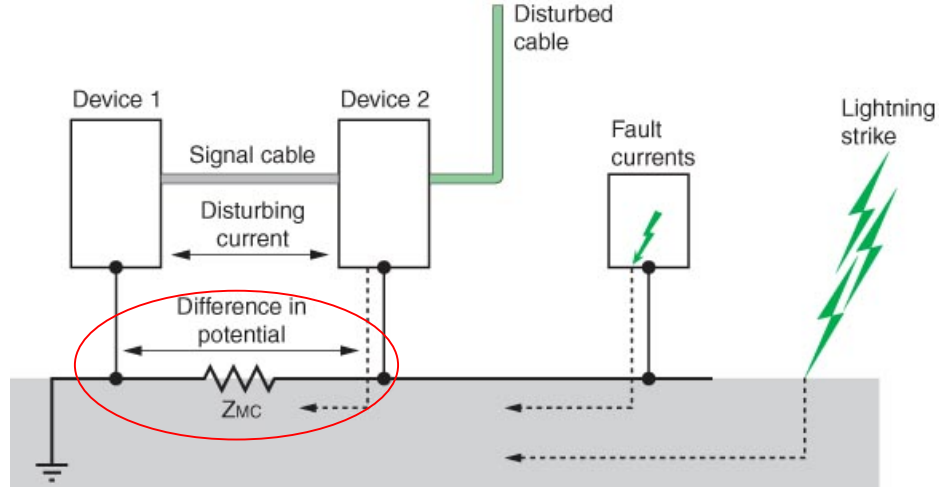
Results

The lines show voltage drops and originate undesired switching

Direct Coupling

To reduce the effects of common-mode impedances:

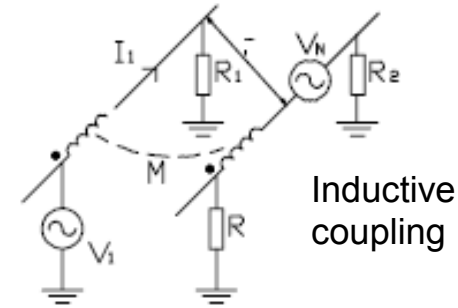
- Mesh the common references,
- Use short cables or flat braids which, for equal sizes, have a lower impedance than round cables,
- Install functional equipotential bonding between devices.



- Reduce the level of the disturbing currents by adding common-mode filtering and differential-mode inductors

Reducing Inductive Coupling

- Reduce mutual inductance between circuits
 - Use twisted pairs signal cables (**A**)
 - Increase the distance between conductors (**r**)
 - Reduce the loop area by galvanic isolation (**A**)
 - Avoid parallel conductors and coils



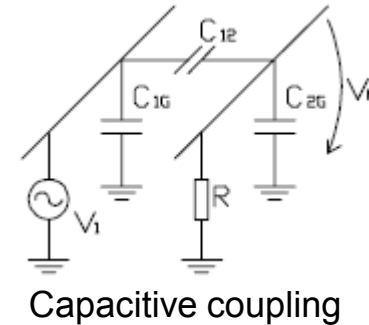
- Reduce the switching frequency (**f**)
- Reduce current of the interfering circuit (**I**)
- Careful routing of wiring (**A**)

$$V_N = j2\pi f \times M_{12} \times I_1$$

$$M_{12} = \mu \times A \cos \theta / 2\pi r$$

Reducing Capacitive Coupling

- Reduce level of high dv/dt noise sources
- Use proper grounding schemes for cable shields
- Use grounded conductive faraday shields to protect against electric fields
- Reduce impedance level of the victim circuit
- Reduce stray capacitance
 - Keep traces short
 - Increase distance between conductors
 - Use metal cases, provide lower impedance discharge through metal planes
 - Use ground plane between conductors
 - Embed non-sensitive signal in between critical signal
 - Use shielded conductors
 - Reduce signal impedance so that only very high frequency noise is coupled



$$V_N = j2\pi f \times V_1 \times C_{12} \times R$$
$$Z = \frac{1}{2\pi C f}$$

A red arrow points from the C_{12} term in the first equation to the impedance formula below. A red circle highlights the C_{12} term in the first equation.

DESIGN PROCESS

Outline

- Introduction
- Overview on Electromagnetic Basics
- Coupling Mechanisms
- **Design Process**
- Standards and Regulations
- Summary

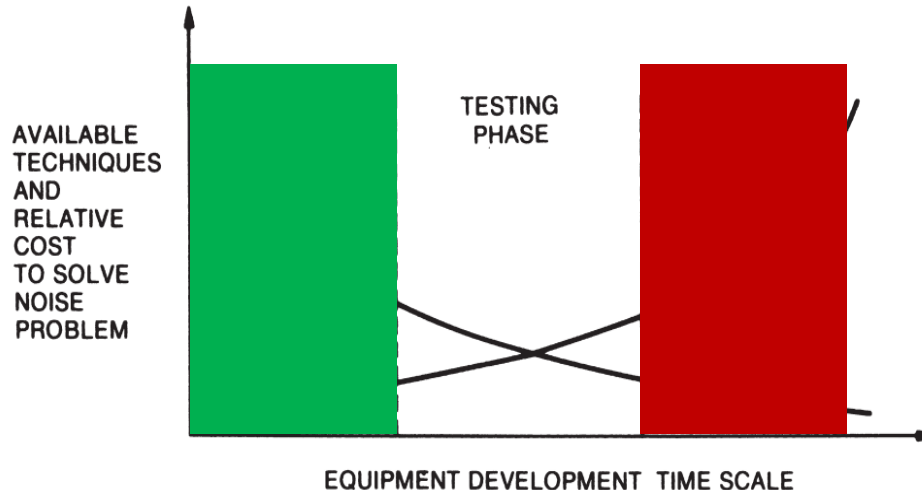
Design Process

EMC can be approached in two very different ways:

Crisis Management : Design your stuff with total disregard of EMC, see how it works, fix problems with add-ons if needed (and if possible!!!)



System Design : Consider EMC right from the beginning. Then it will be designed into instead of added onto the product.



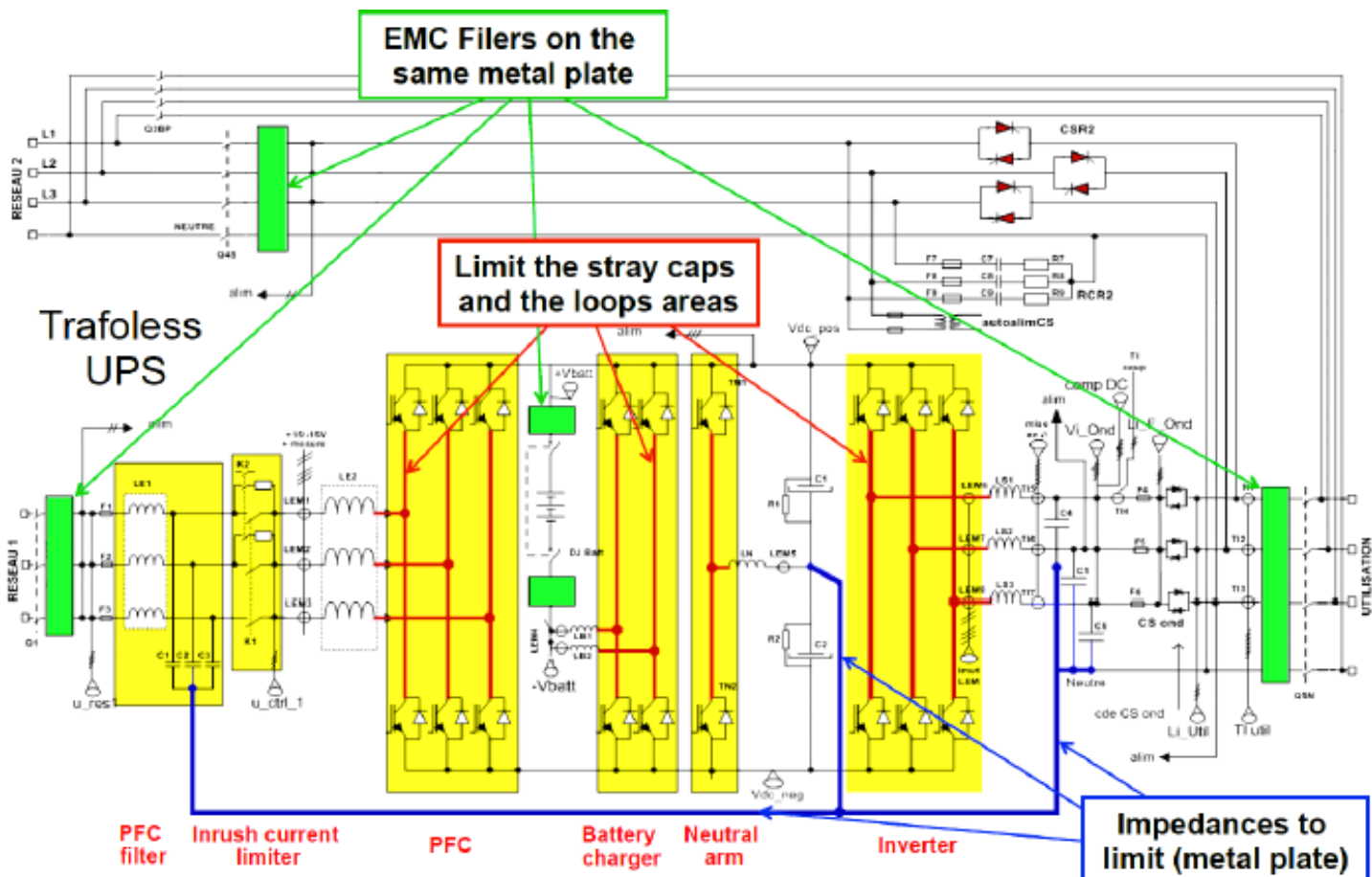
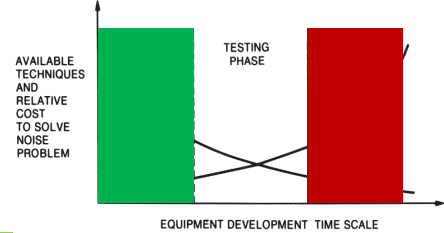


Fig. 11: Example of UPS schematic diagram

Design Process

EMC Design Flow Diagram



- Identify system requirements & installation environment, etc.
- Describe EMC requirements, review contract & recommendations

Pre-study

- Develop an EMC control plan
 - Interference prediction (identify source/victims, use zone concept, make installation plan, equipotential bonding, collect best practices, etc.)
 - Design testing
 - Electrical and mechanical design reviews
 - Amend the EMC control plan, as necessary

Design

- Liaison with manufacturing
- In-process inspection during manufacturing

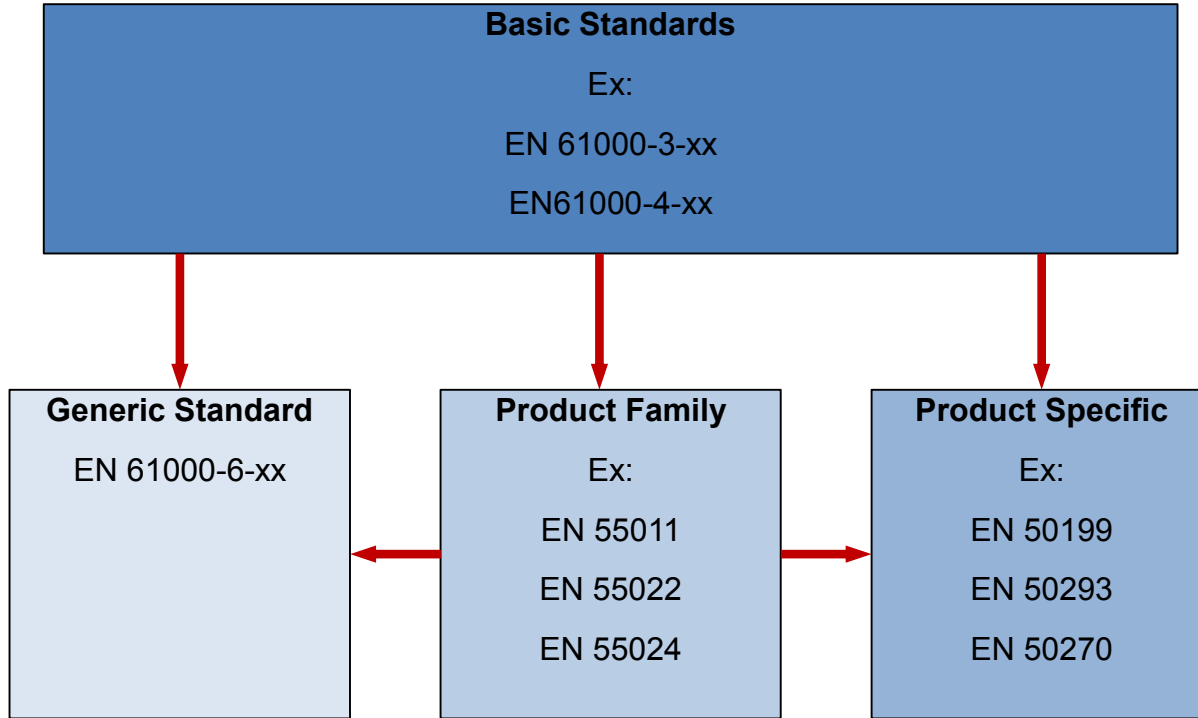
Manufactur
e

- Performance of EMC qualification tests
- Redesign and retest where necessary
- Preparation and submittal of EMC test report or declaration

Test

STEP 1: Identify the Requirements

a). Standards, customer requirements, environment, etc.



STEP 1: Identify the Requirements

b). System category

Power System Categories – IEC 61800-3-2

Category C1: Converter system of rated voltage less than 1kV, intended for use in the first environment (ex. household products).

Category C2: Converter system of rated voltage less than 1kV, which is neither a plug in device nor a movable device and, when used in the first environment, is intended to be installed and commissioned only by a professional (ex. UPS for offices).

Category C3: Converter system of rated voltage less than 1kV, intended for use in the second environment and not intended for use in the first environment (ex. low voltage STATCOM).

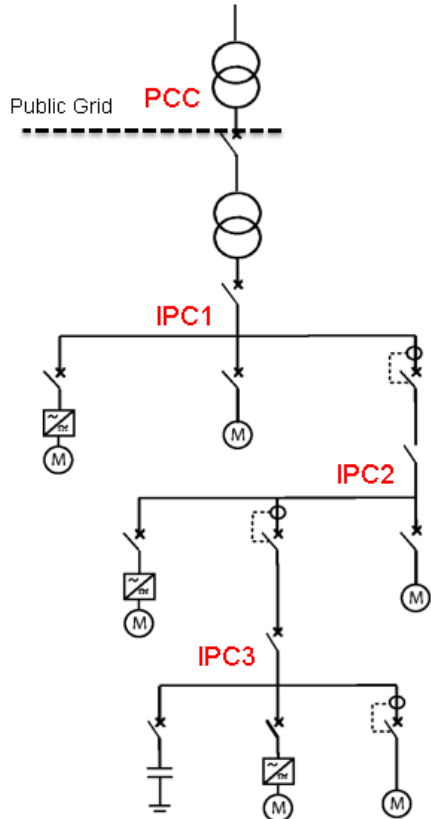
Category C4: Converter system of rated voltage equal to or above 1kV, or rated current equal to or above 400A, or intended for use in complex systems in the second environment.



ref: ABB

STEP 1: Identify the Requirements

c). Electromagnetic classes



PCC: Point of common coupling
IPC Internal point of coupling

Electromagnetic Classes – IEC 61000-2-4

CLASS	DESCRIPTION	THDv (%)
CLASS 1	This class applies to protected feeders and has compatibility levels that are lower than the level of the public supply system. It is related to the use of the equipment very sensible to the supply distribution distortions, as the electric instruments of technological laboratories, some kind of automatic equipment and protection equipment, some computers, etc.	5%
CLASS 2	This class applies generally to PCCs and to IPCs in the environments of industrial and other non-public power supplies. The compatibility levels of this class are generally identical to those of public networks. Therefore, components designed for supply from public networks may be used in this class of industrial environment.	8%
CLASS 3	This class applies only to IPCs in industrial environments . It has higher compatibility levels for some disturbance variables than Class 2. For example, this class should be considered when one of the following conditions applies: <ul style="list-style-type: none">• The main part of the load is supplied via converters;• Welding machines are used;• Large motors are started frequently;• Loads vary quickly	10%

STEP 1: Identify the Requirements

d). Environment classes

Environment Classes – IEC 61800-3-2

First Environment includes domestic premises. It also includes establishments directly connected without intermediate transformer to a low-voltage power supply network which supplies buildings used for domestic purposes.

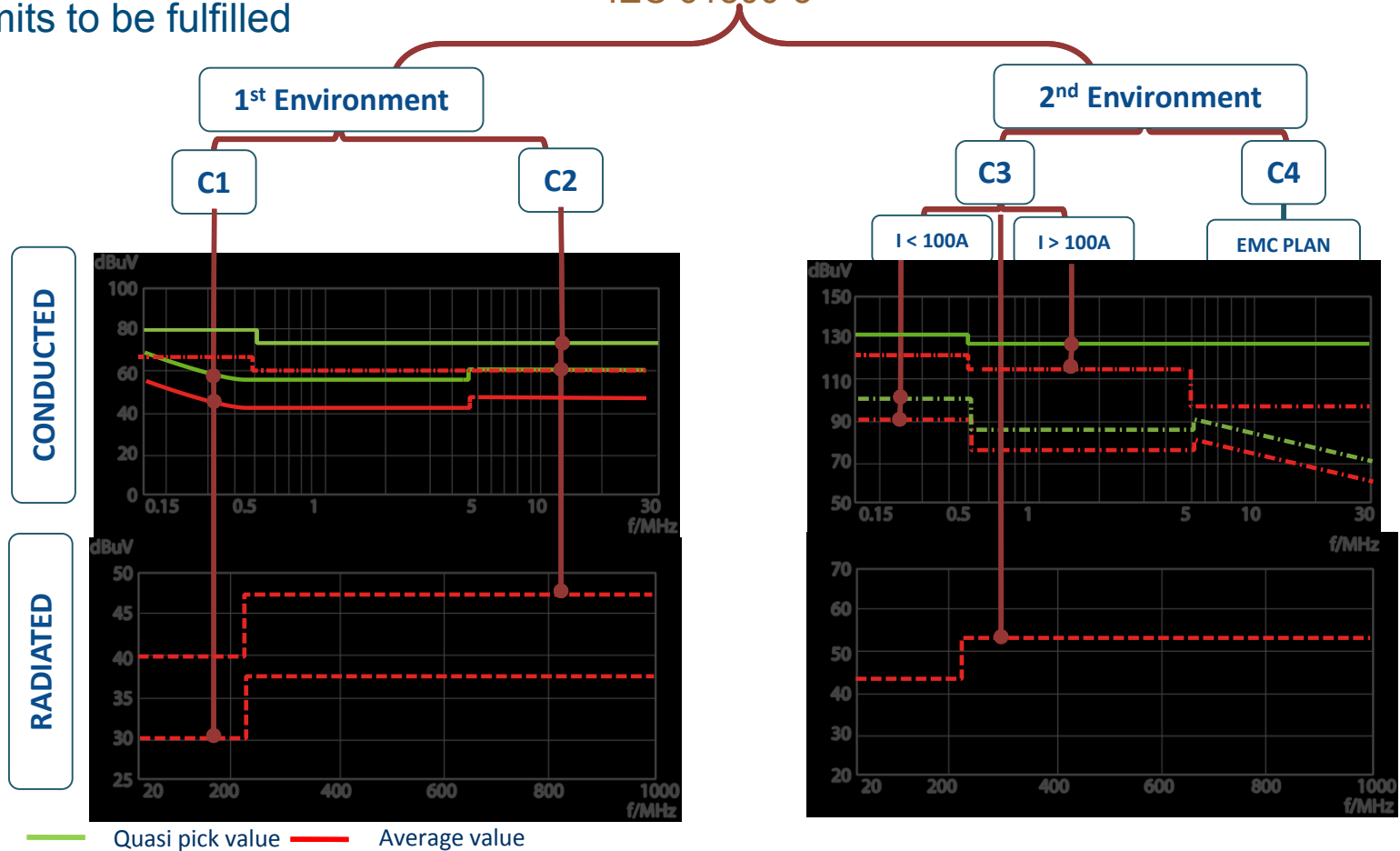
Second Environment includes all establishments other than those directly connected to a low voltage power supply network which supplies buildings used for domestic purposes.

Classifying Criteria			Application Limit
<i>First environment</i>	Non restricted distribution	<1000V	C1
	Restricted distribution	<1000V	C2
<i>Second environment</i>	Input current $\leq 100A$	<1000V	C3
	Input current $> 100A$	>1000V	C4

STEP 1: Identify the Requirements

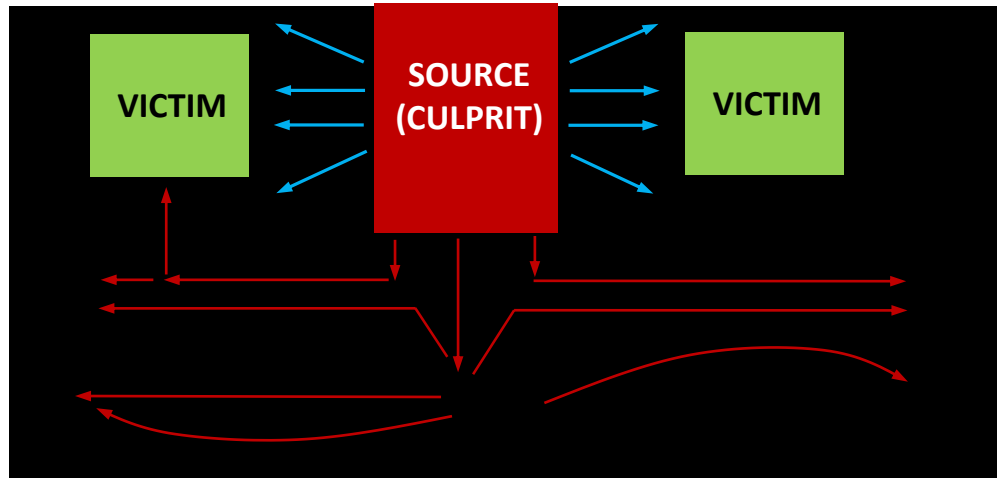
IEC 61800-3

e). Limits to be fulfilled



STEP 2: Change Noise Characteristics at „Source“

System has to deal with two kind of emissions:



▣ **RADIATED**

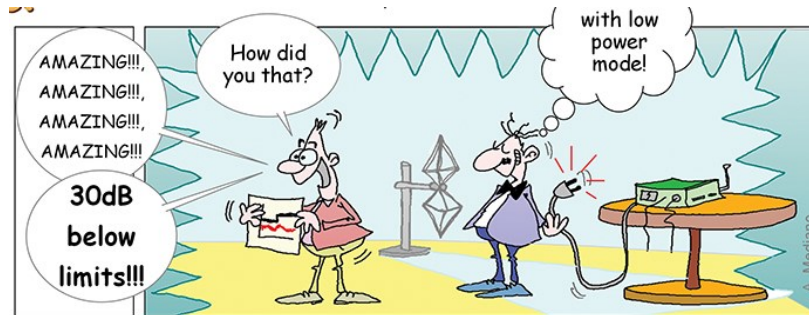
▣ **CONDUCTED**

STEP 2: Change Noise Characteristics at „Source“

- ✓ Decrease high di/dt current → I ↙
- ✓ Slow down switching action → f ↙
- ✓ Reduce high frequency path enclosed area → A ↘
- ✓ Minimize stray inductance in the power path

$$E \propto f^2 \cdot \frac{1}{r} \cdot I \cdot A$$

Diagram illustrating the relationship between noise voltage (E) and various parameters: frequency (f), distance (r), current (I), and area (A). The equation is $E \propto f^2 \cdot \frac{1}{r} \cdot I \cdot A$. Red circles highlight each variable, and red arrows point from the variables to the list of actions on the left.



Ref: <http://incompliancemag.com>

STEP 2: Change Noise Characteristics at „Source“

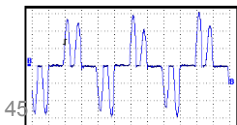
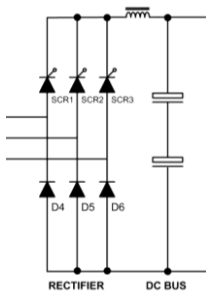
a). Topology

- ✓ Decrease high di/dt current
- ✓ Slow down switching action
- ✓ Reduce high frequency path enclosed area
- ✓ Minimize stray inductance in the power path!!!

$$E \propto f^2 \cdot \frac{1}{r} \cdot I \cdot A$$

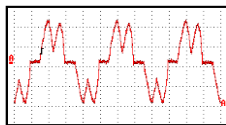
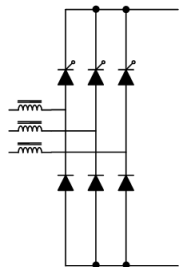
DC CHOKES

THDi \approx 40%



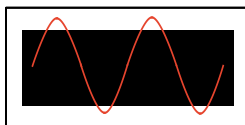
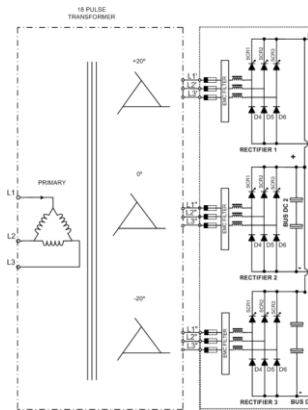
CHOKES 3%

THDi <35%



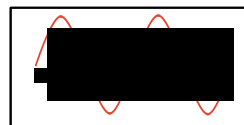
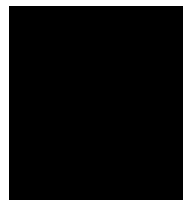
MULTIPULSE

THDi <15%



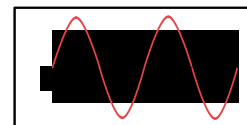
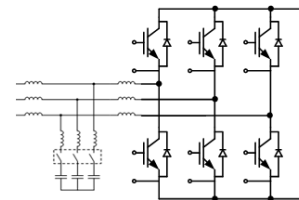
NOTCH FILTER

THDi <5%

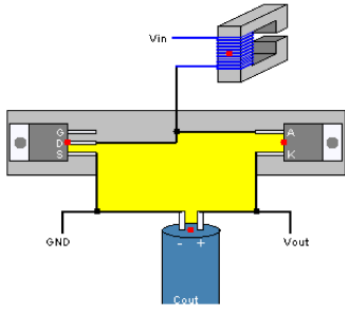


AFC

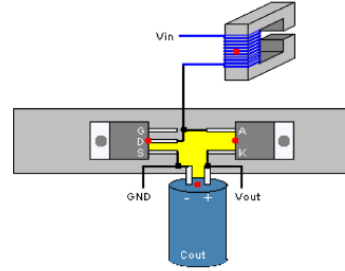
THDi <4%



STEP 3: Reduce Switching Path Enclosed Area

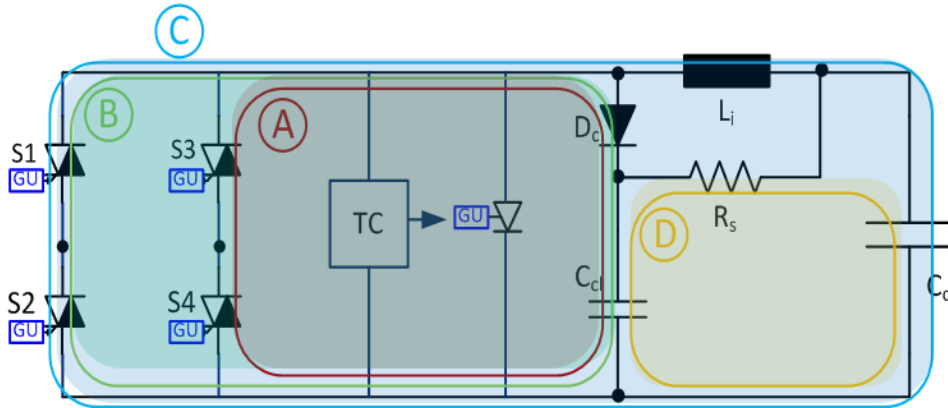


Overvoltage 75%



Overvoltage 32%

$$E \propto f^2 \cdot \frac{1}{r} \cdot I \cdot A$$



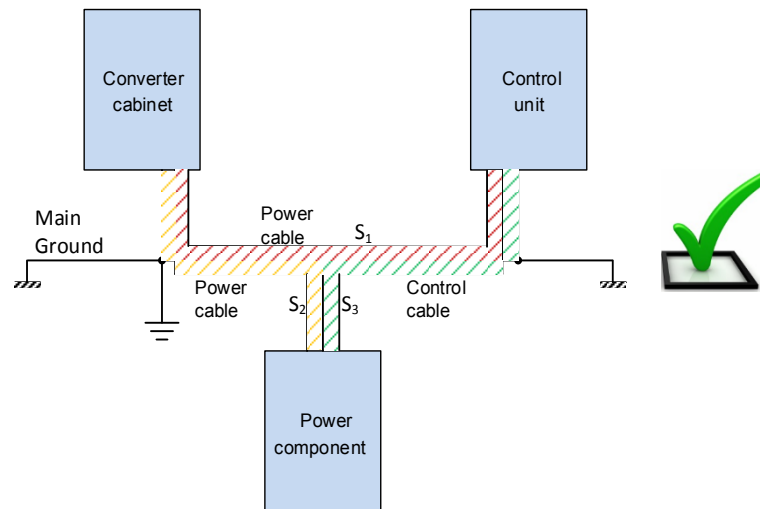
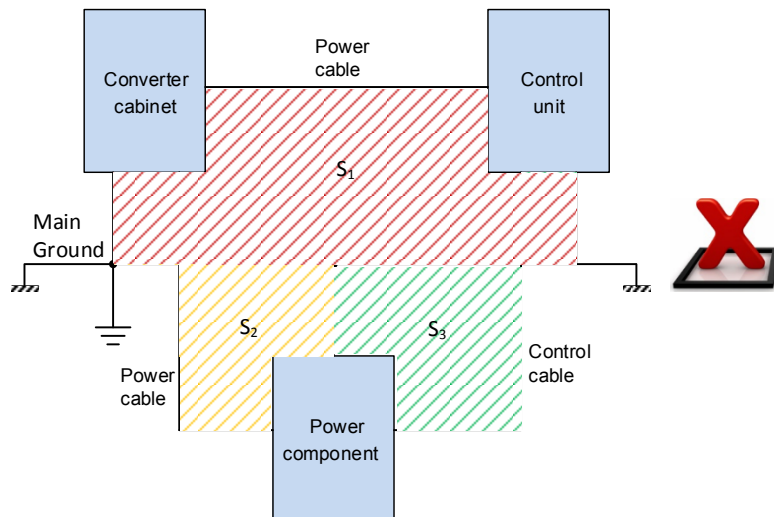
○ circuit inductance



ref: ABB

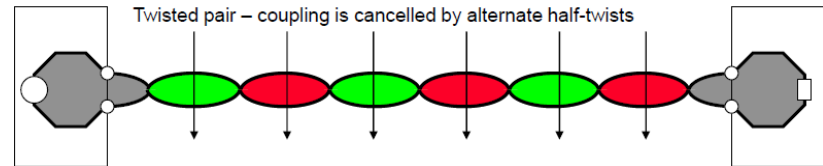
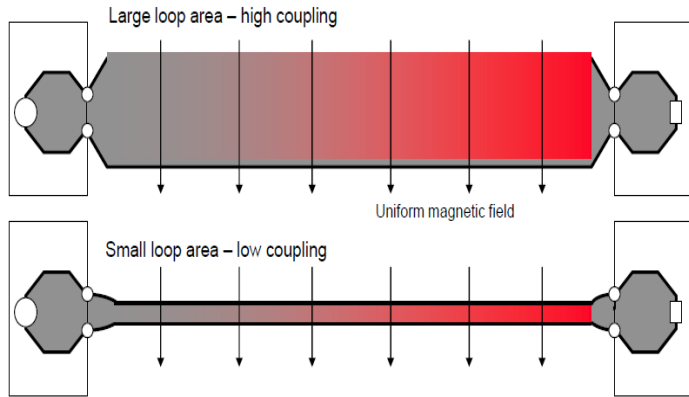
STEP 3: Reduce Switching Path Enclosed Area

$$E \propto f^2 \cdot \frac{1}{r} \cdot I \cdot A$$



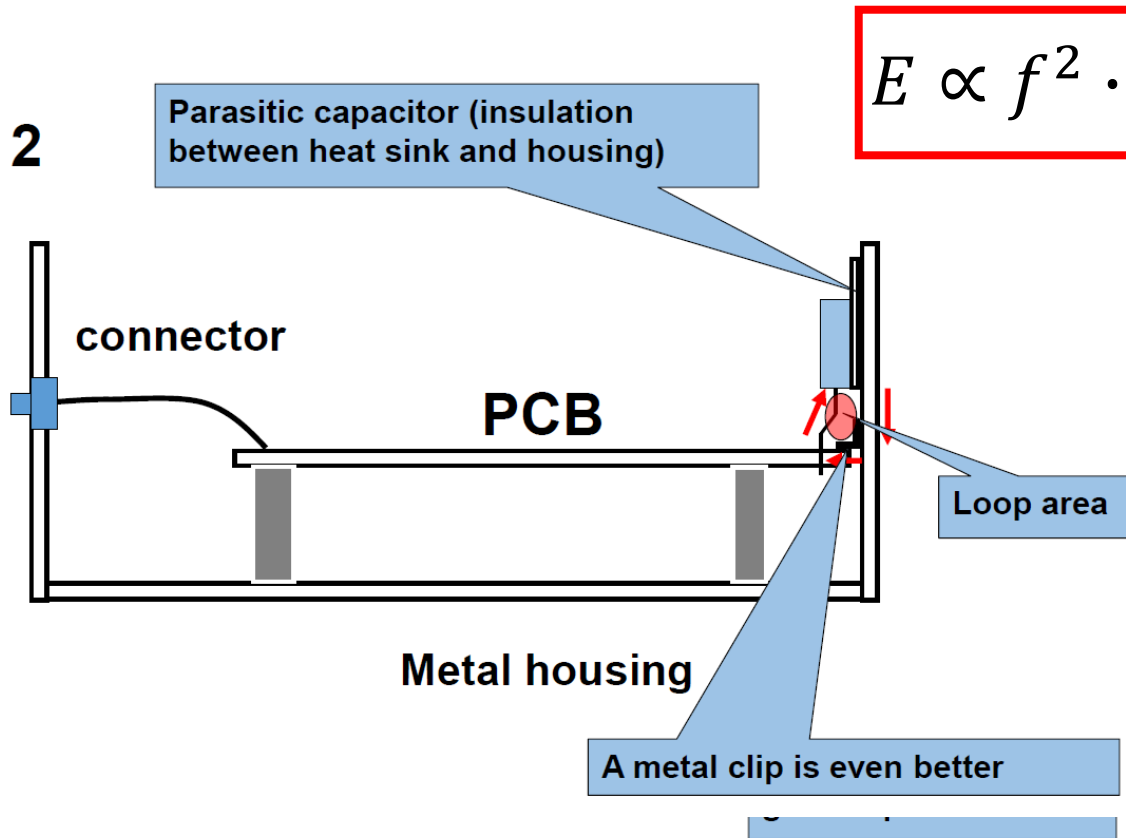
STEP 3: Reduce Switching Path Enclosed Area

$$E \propto f^2 \cdot \frac{1}{r} \cdot I \cdot A$$



STEP 3: Reduce Switching Path Enclosed Area

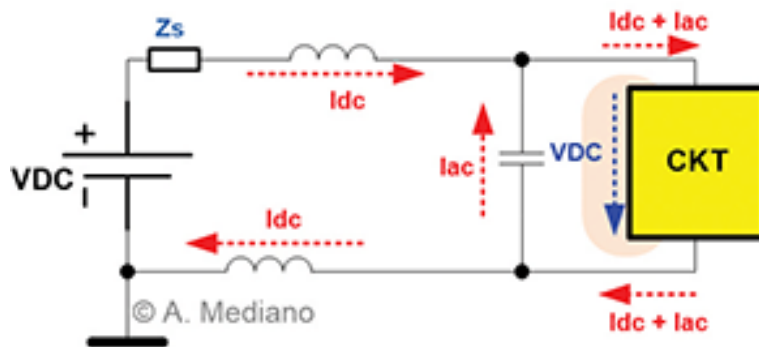
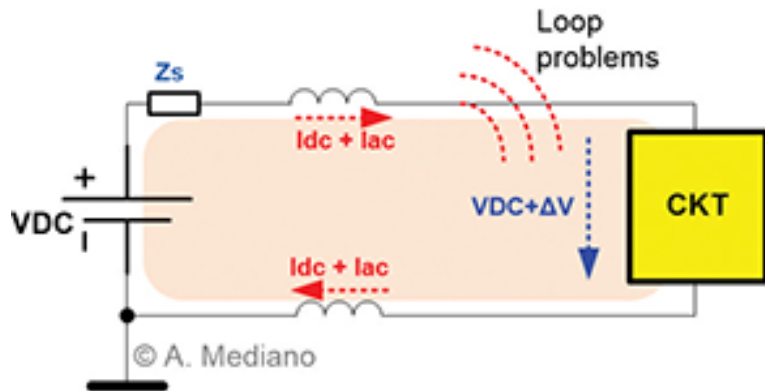
Example 2



Ref: "Common mode current currents in power devices: do you know where they flow? ", Lex de Rijck, ECPE'17

STEP 3: Reduce Switching Path Enclosed Area

EMI: do not forget compromises! by Arturo Mediano

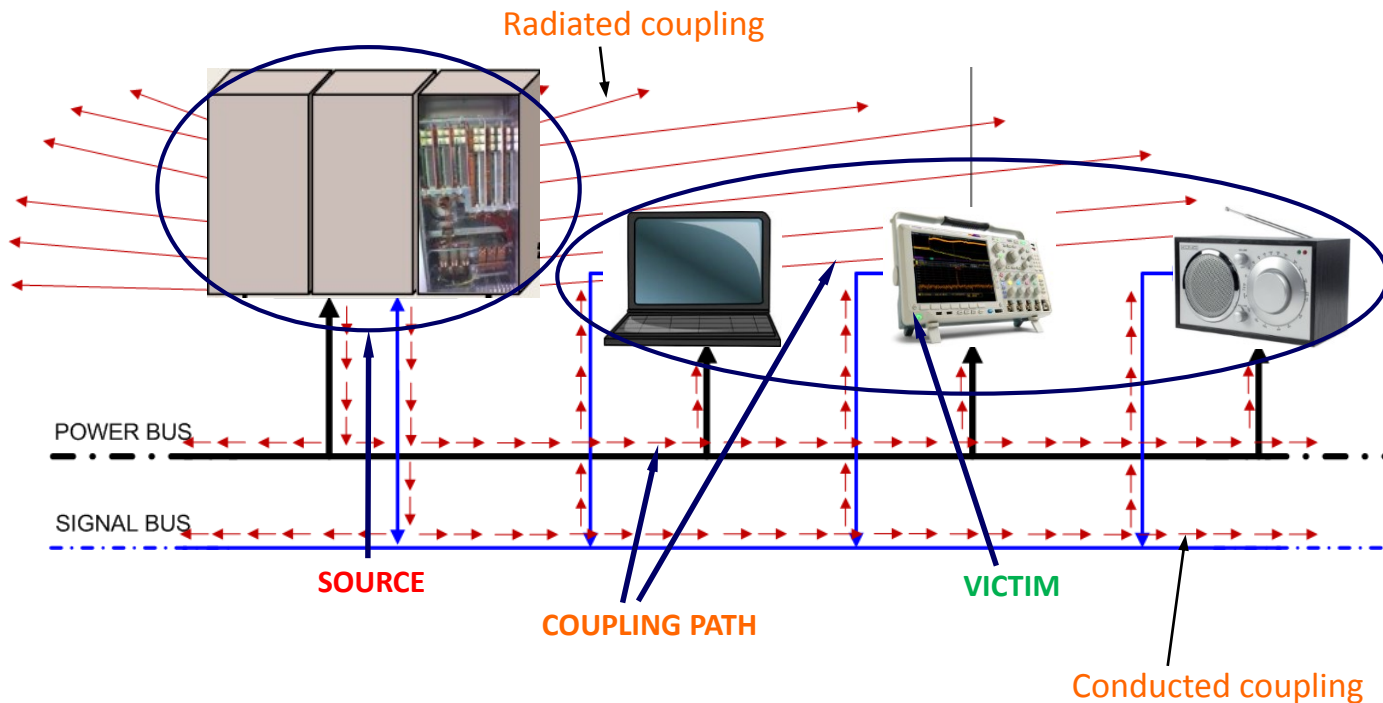


A simple capacitor (100nF) has traditionally been an effective solution for the frequency range below 30-50MHz to decouple the circuits but for higher frequencies it gets more complex.

STEP 4: Zoning

a). Sources, victims, coupling paths?

Define the culprits (sources), victims (sensitive circuits) and possible coupling paths.



STEP 4: Zoning

b). Group components depending on their ZONES

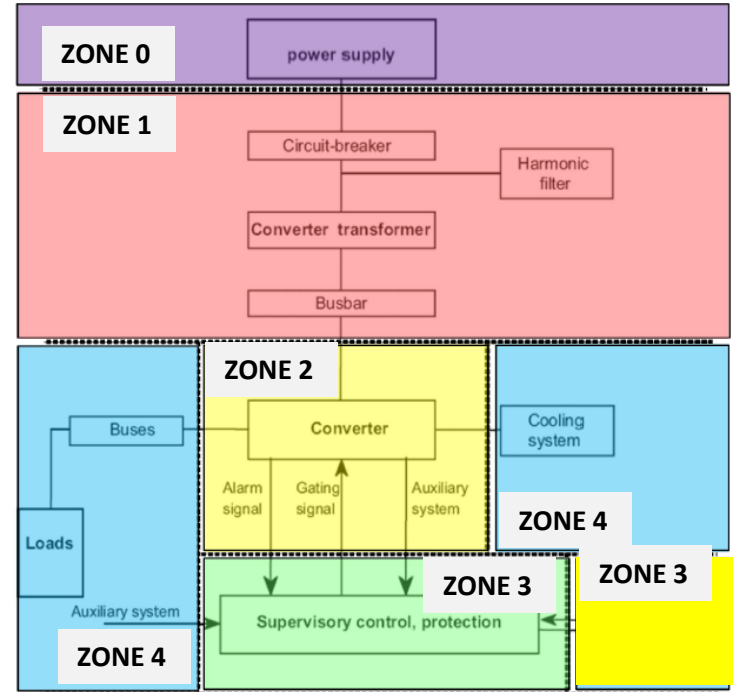
Zone 0: HV transformer, disconnectors, circuit breakers, busbars etc. belong to Zone 0.

Zone 1: MV transformer, disconnectors, auxiliary power supply transformers (if connected to MV), cables/busbars, filters etc. belong to Zone 1.

Zone 2: The environment with the highest pollution from electromagnetic interference is located in this section in which the converter is also placed itself.

Zone 3: Processors and low voltage components that are operated at high frequency and/or sensitive to conducted or transmitted EM fields. It shall be designed as far as possible as a Faraday cage and special attention is required for the incoming and outgoing lines of this zone.

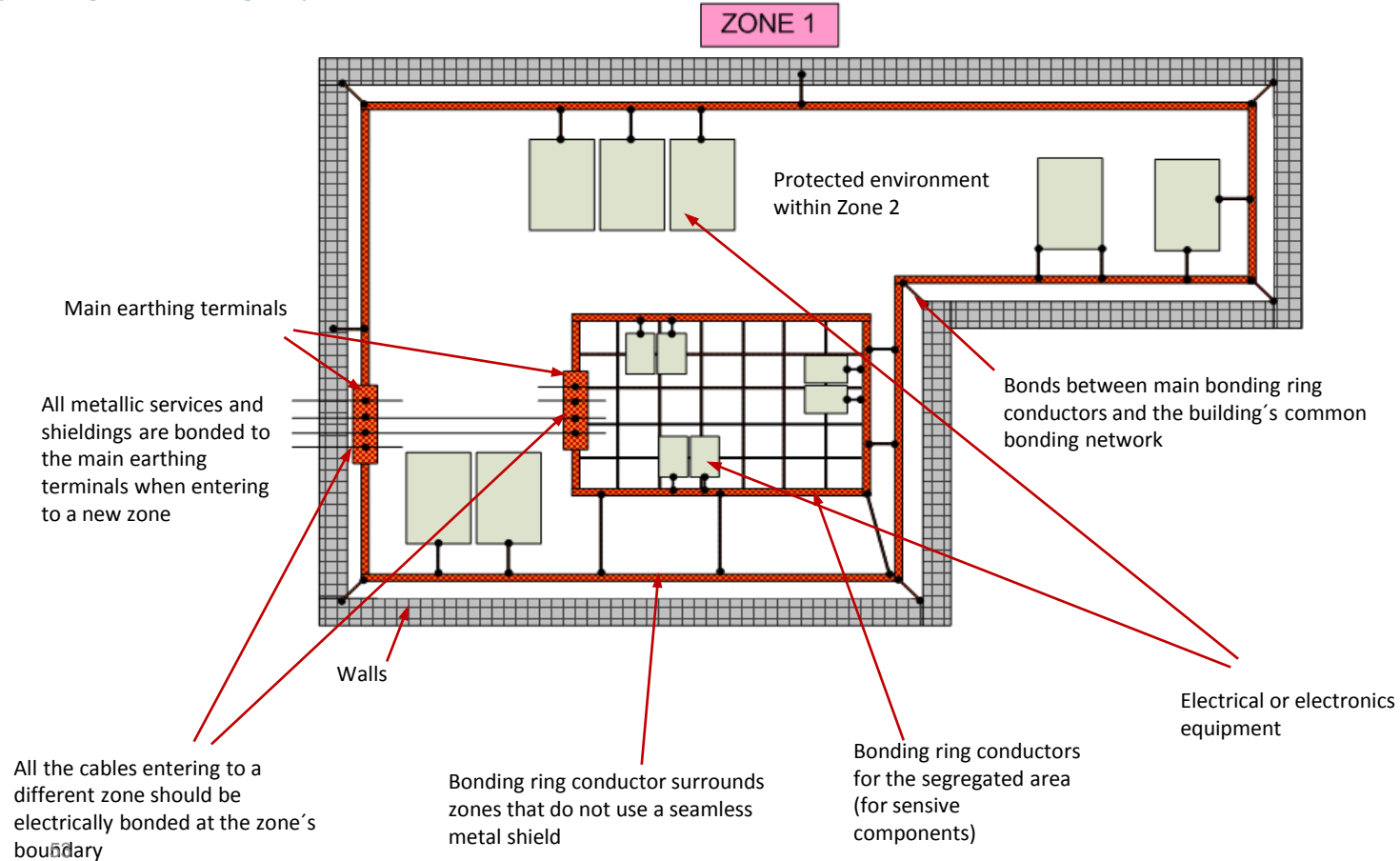
Zone 4: Cooling system, loads, etc. belong to this zone.



Ref: IEC 61800-3

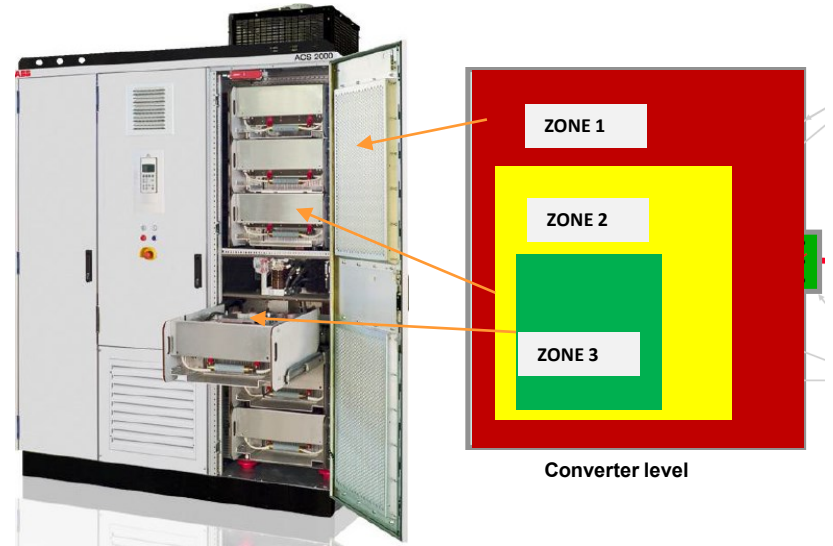
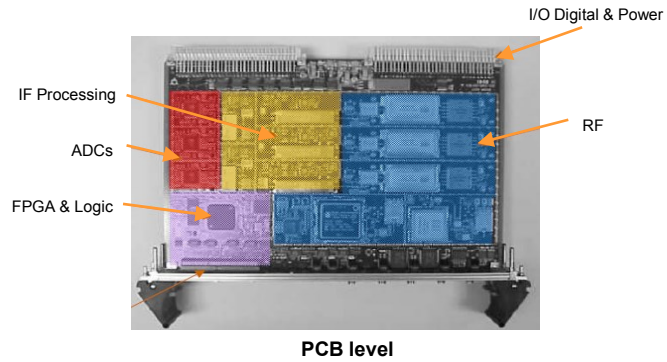
STEP 4: Zoning

c). Prepare grounding layout for each zone



STEP 4: Zoning

d). Place the ZONES accordingly



STEP 5: Cabling

a). Classify the cables

Cable classes:

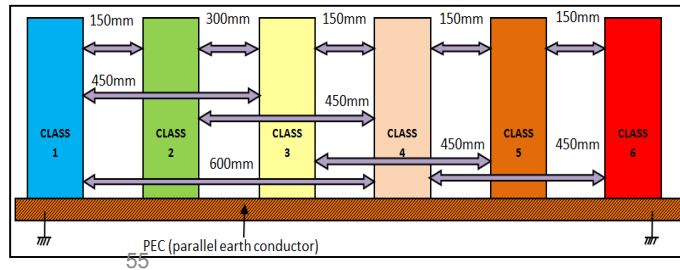
Class ① Very sensitive signal and data cables. High quality twisted pair cables with 360° shielding are required.

Class ② Slightly sensitive signals (4-20mA or 0-10V), analogue signals, low rate digital signals (RS422, RS485). 230/415V can also be treated as Class 2 inside an enclosure, after it has been filtered in the cabinet.

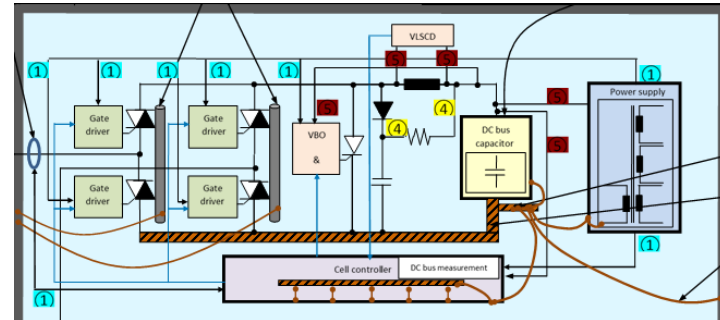
Class ③ Slightly interfering cables, AC cables (230/415V), DC cables, control circuits with resistive and inductive loads. They can be shielded, twisted cables highly required. Screw terminals are allowed as long as the exposed conductors are less than 30mm long.

Class ④ Power cables with a high noise level (e.g. motor cables, welding equipment etc.) with $U > 230\text{ V}$. ..1 kV. Pigtails are not allowed. The conductors should be twisted. Relays solenoids, contactors, etc. may use unshielded twisted pairs only if they operate infrequently ($t \gg 5\text{min}$).

Class ⑤ **Class ⑤** Medium-voltage and high voltage cables with $U > 1\text{ kV}$. These cables are more exposed to external disturbances (lightning, powerful surges, transients etc.)

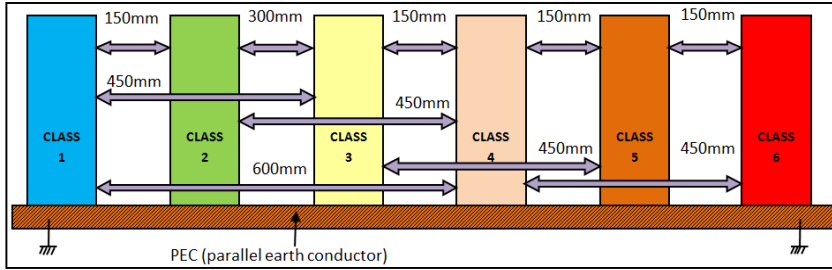


*where the cable are not shielded an $L > 30\text{m}$



STEP 5: Cabling

b). Separate the cables



Larger spacing may sometimes be required for classes 5 and 6 for insulation purposes, or for preventing damaging flash-overs during fault conditions.

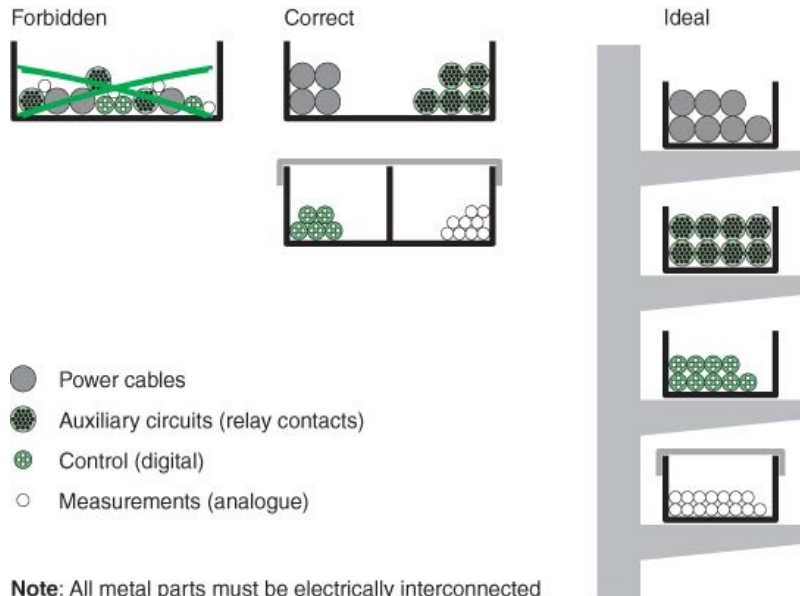
Cable list and cable deals

Use	Class	Minimum distance between neighbor cable (or busbar)	Shield	Shield connection	Installation type
Current transducer cables	1	1-4 → 40mm 1-5 → 50mm	yes	Connected to cell controller's minus potential from cell controller's side, the other side is floating	Same grounding potential with the cell
Busbars inside the converter	5	5-1 → 50mm 5-4 → 10mm	no	-	Insulated, no direct contact with grounded metal parts
24Vdc and 48Vdc auxiliary cables	1	1-3 → 240mm	yes	Cable shield will be connected to ground on both sides	From converter base frame side it will be connected base frame common grounding busbar. On the controller side it will be connected to the common grounding busbar in the frame. Needs 360° shielding connection.

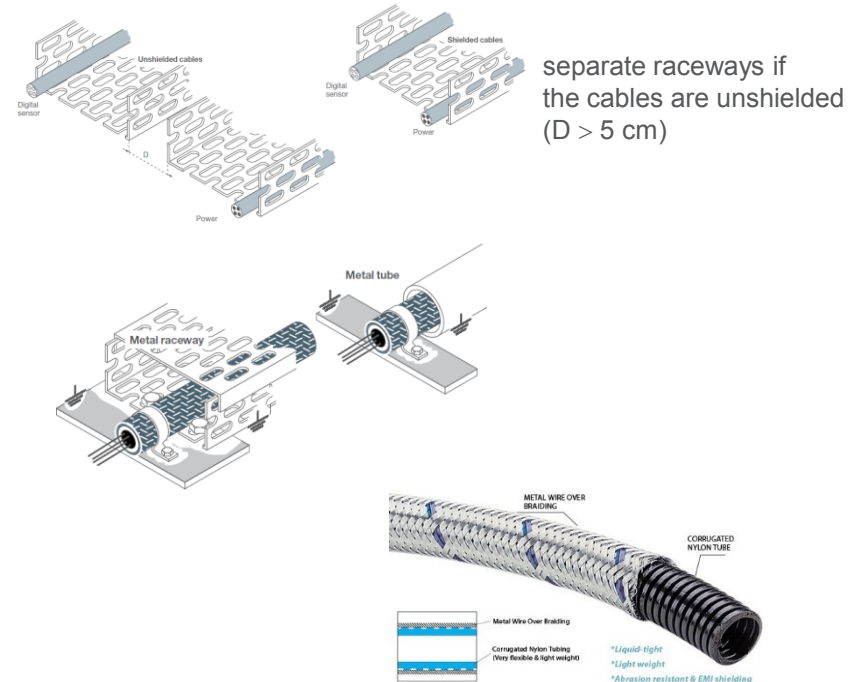
STEP 5: Cabling

b). Separate the cables

- Cables on the same class may be bundled.
- If there is no PEC, spacing between classes of **at least ten times the diameter of the larger bundle** ($l > 10 \times d$) is required.
- When the cable is too close to the EMI source the shield should be bonded several times or capacitors can be used instead of direct bonds.

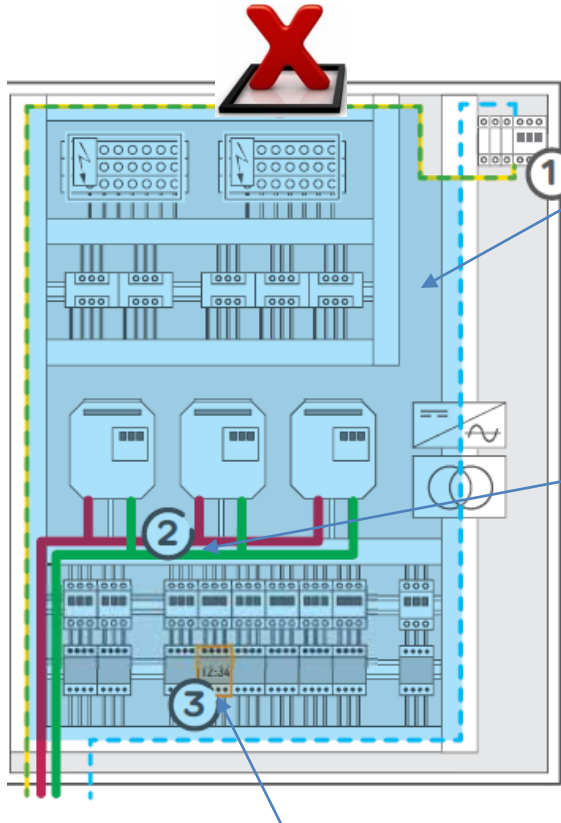


Note: All metal parts must be electrically interconnected



STEP 5: Cabling

c). Make a cable routing plan



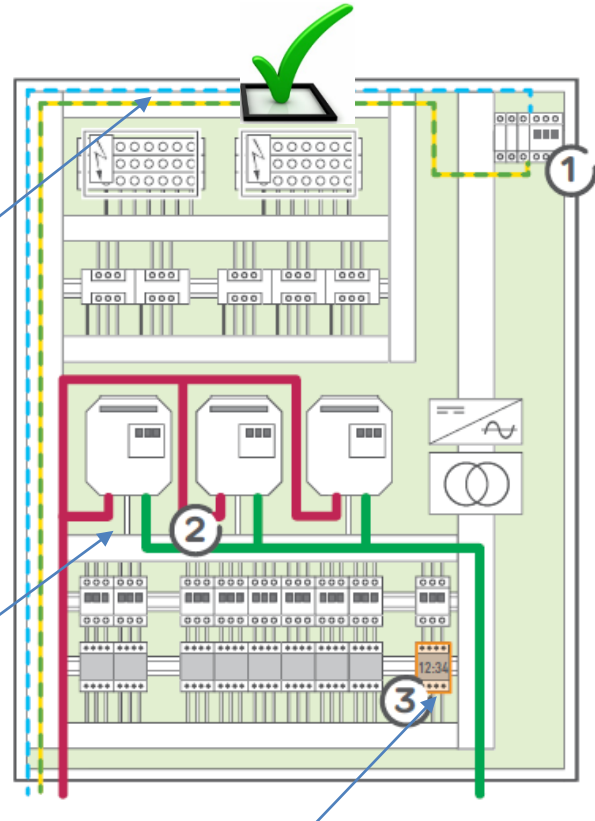
A time switch is installed between two contactors, it risks malfunctions during contactor switching.

The power and earth cables form a large loop.

The cables are held against one another to reduce the surface area of the inductive loop.

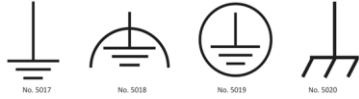
The upstream and downstream power cables of the variable speed drives run alongside one another creating a transfer of disturbance.

The upstream and downstream cables follow separate paths. If necessary the cross another at right angles.

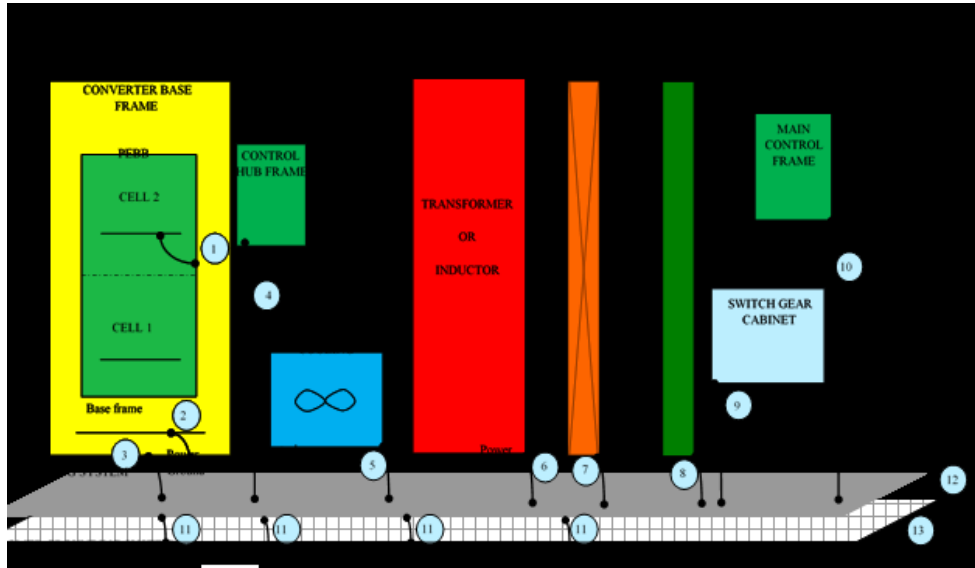


The time switch is remote from the contactors.

STEP 6: Grounding

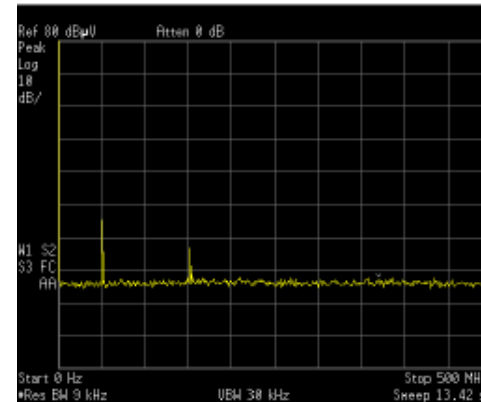
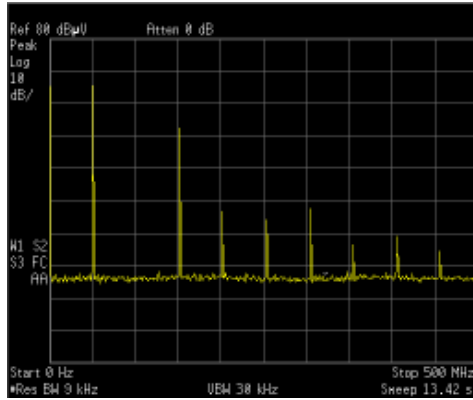
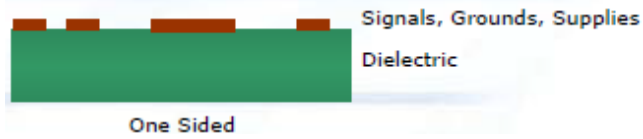


When you see these symbols there is always an EMC work to be done around!...



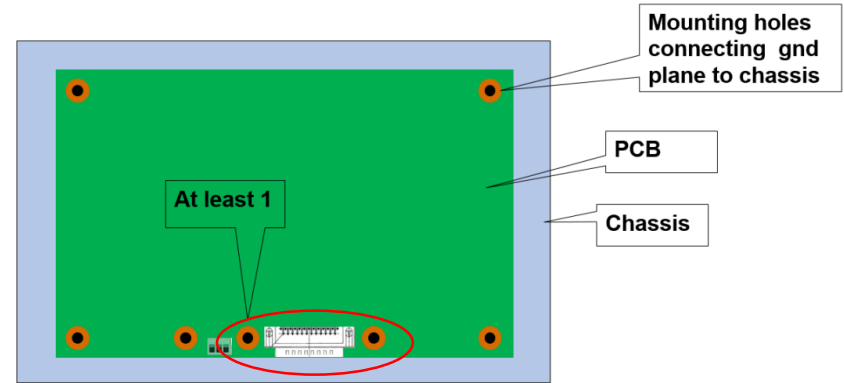
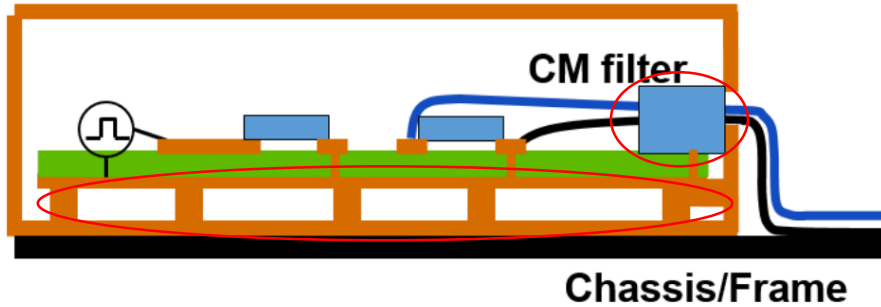
- System grounding should be **less than 0.1Ω** .
- Ground rod length, number, placement, and spacing affect the resistivity of the path to earth.
- Separate the clean and dirty grounding.
- All classified groundings should be connected directly to the meshed grounding.

STEP 6: Grounding



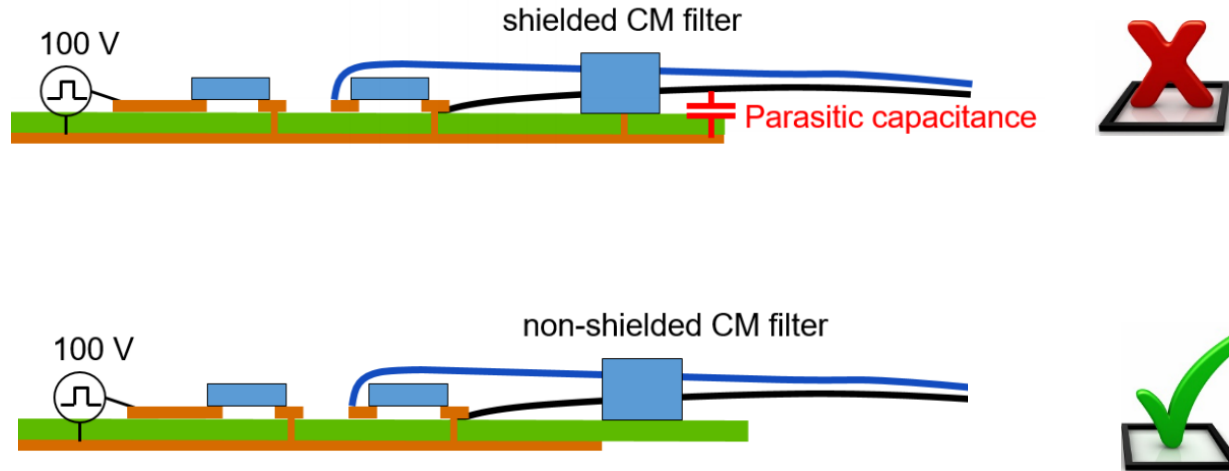
Adding ground plane reduces emission of fundamental ≈ 40 dB

STEP 6: Grounding



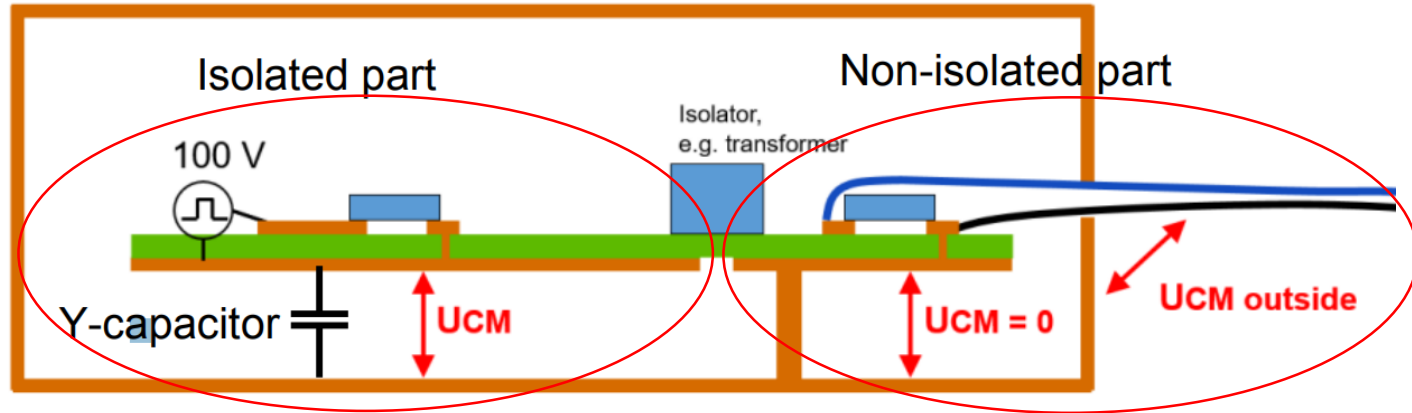
- Connect the ground plane of the PCB with multiple metal studs to the housing or metal plate.
- Use CM-filters at the entry point of cables going in or out.
- Place ground-plane-to-housing-studs near connectors

STEP 6: Grounding



- The end of the ground plane will have a parasitic capacitance between the plane and the outgoing cables.
- Use a non-shielded CM-filter at the entry point of cables going in or out.
- Retract the ground plane under the filter.

STEP 6: Grounding



- Connect the ground plane of the non-isolated part with the metal housing or metal plate.
- The isolated part can be connected to the housing via Y-caps to further reduce EMI.

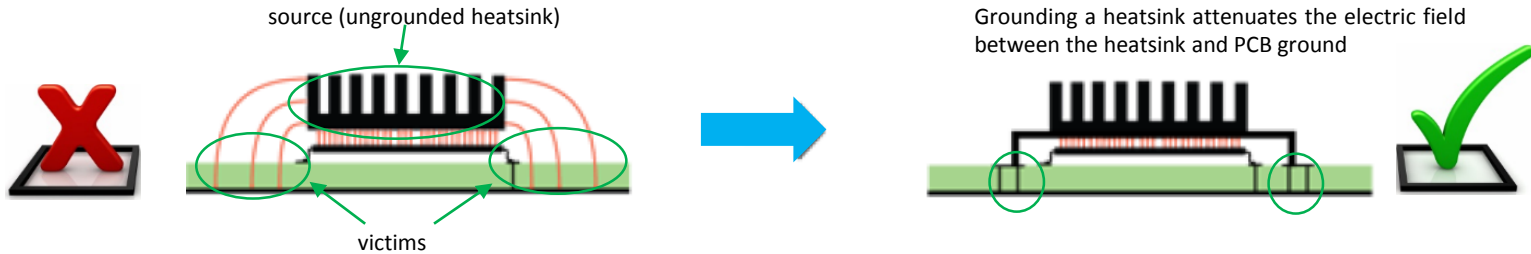
STEP 6: Grounding

a). Grounding at circuit level



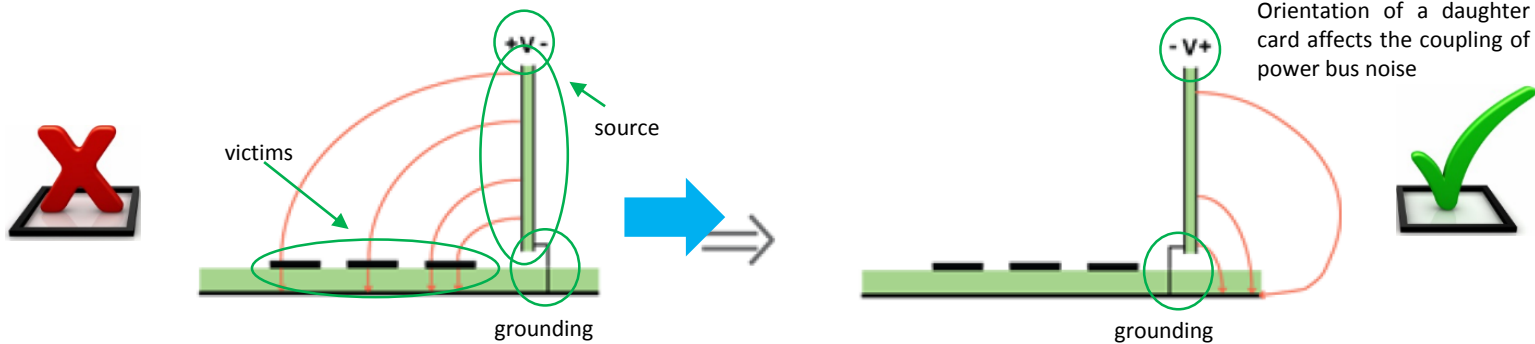
STEP 6: Grounding

a). Grounding at circuit level



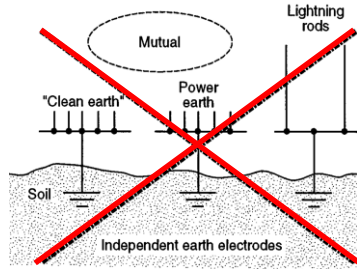
STEP 6: Grounding

a). Grounding at circuit level



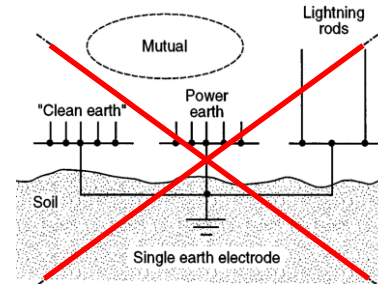
STEP 6: Grounding

b). Grounding at system level



In case of lightning or system fault, dangerous transient voltages can occur between the isolated earthing and the other independently earthed networks.

a). Independent earth electrodes (not suggested).

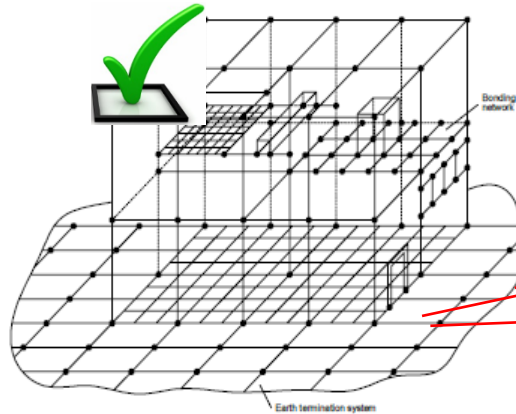


Disturbance signals can circulate between dirty power earthing and clean signal earthing, not suitable for EMC reasons.

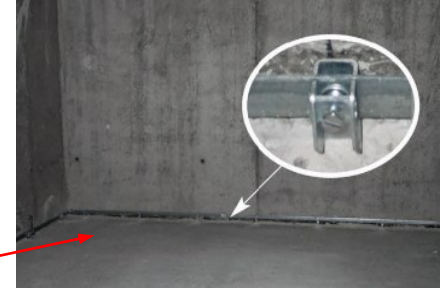
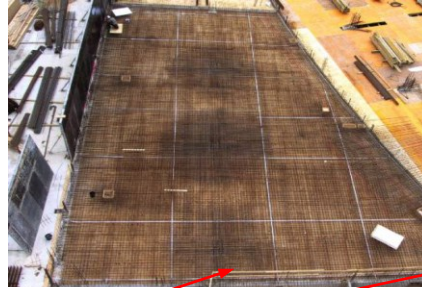
b). Single earth electrode (not suggested).

STEP 6: Grounding

b). Grounding at system level



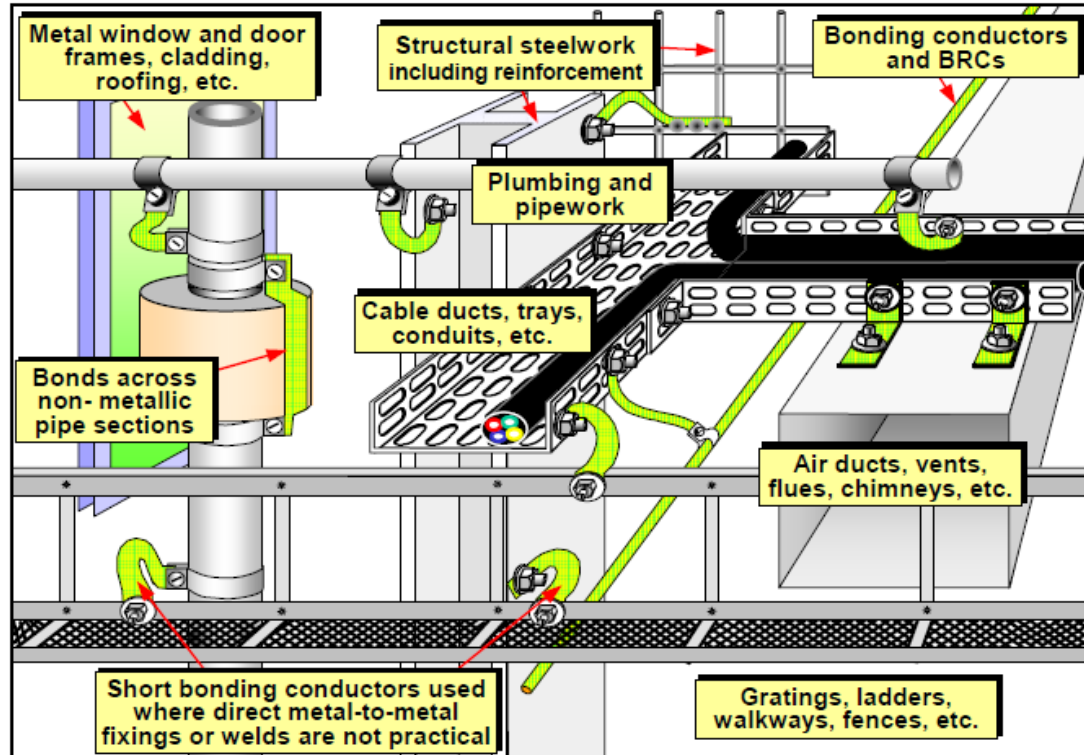
c). Bonded earth electrodes (suggested).



STEP 6: Grounding

b). Grounding at system level

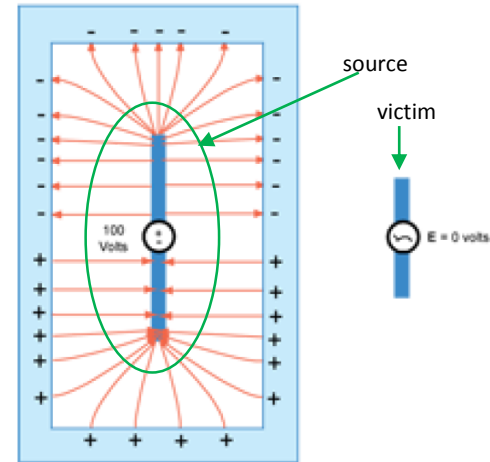
Creating a MESH-CBN by bonding 'natural' metalwork



STEP 7: Improve the Immunity of Receptor

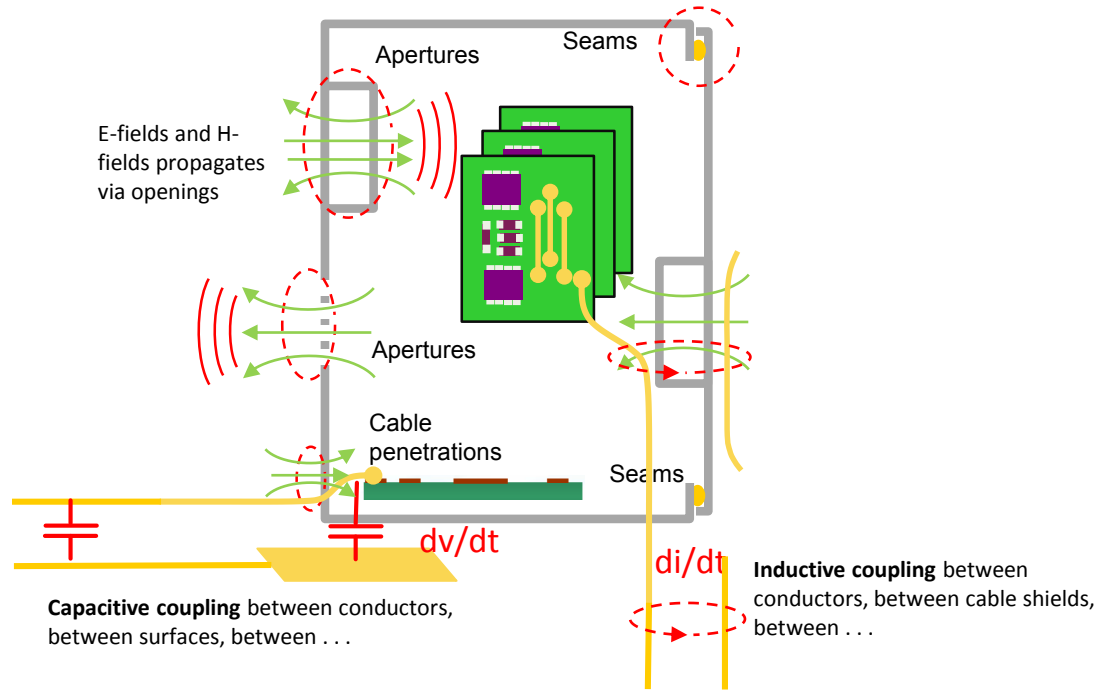
Shielding, apertures, seams, cable penetration...

Every **seam**, every **aperture** and every **cable penetration** have to be evaluated carefully to ensure that no significant interfering signals are allowed to pass from one side to the other.



STEP 7: Improve the Immunity of Receptor

Shielding, apertures, seams, cable penetration...

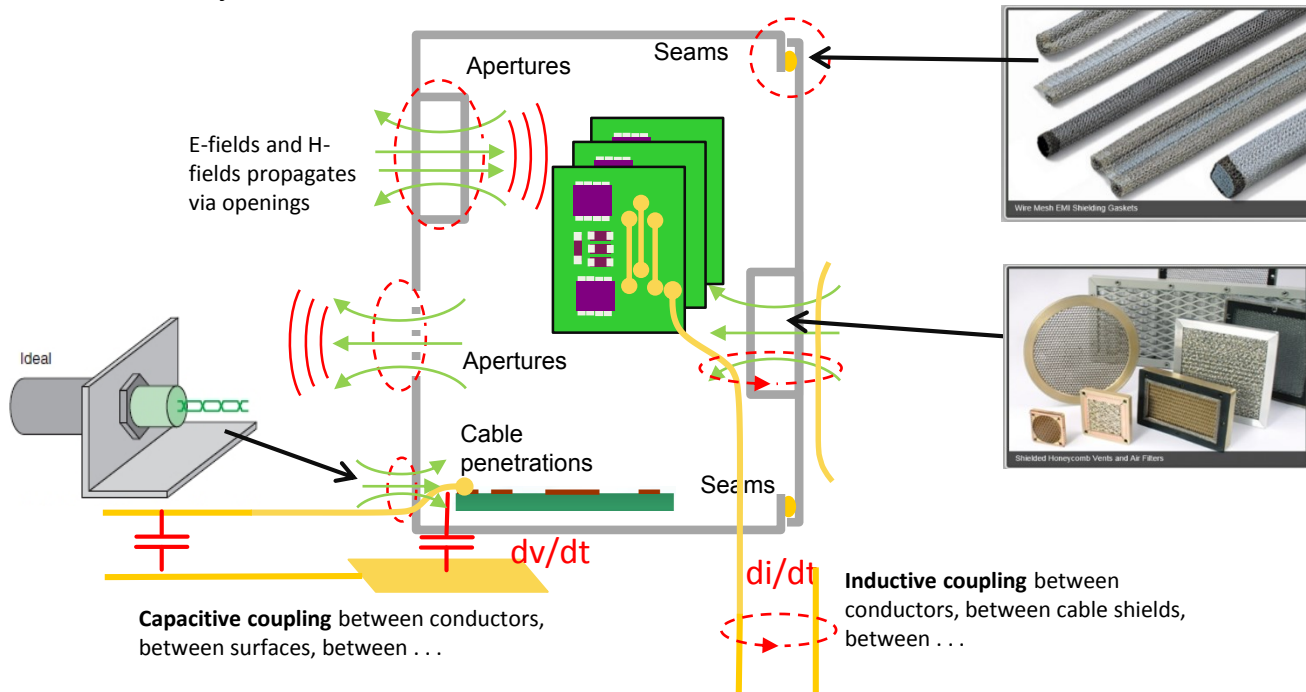


STEP 7: Improve the Immunity of Receptor

Shielding, apertures, seams, cable penetration...

To provide shielding, currents must flow on the surface of the enclosure. To have a good shielding:

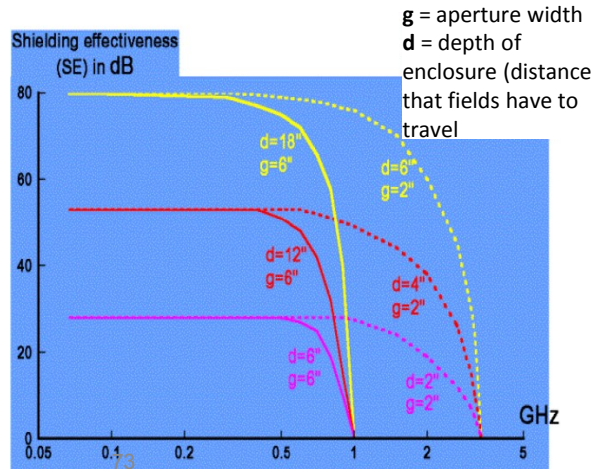
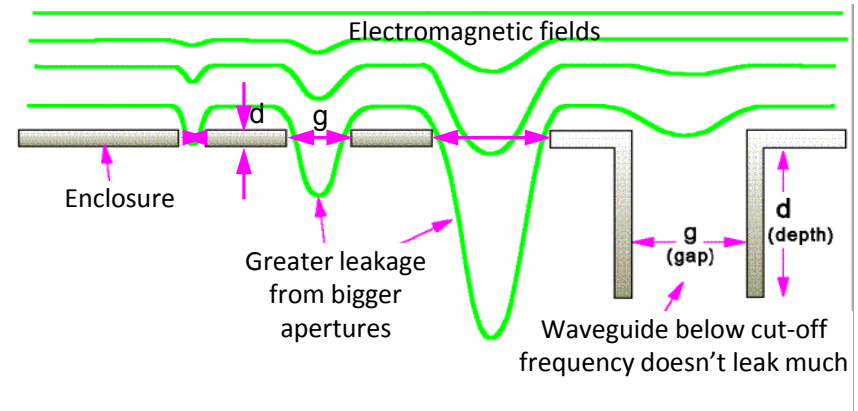
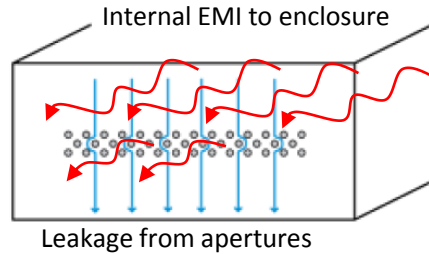
- ✓ Minimize size and number of apertures and seams
- ✓ Use gaskets/spring-fingers to seal metal-to-metal interface
- ✓ Interfaces free of paint and debris
- ✓ Ground contact should always be effective 360 around the cable termination.



STEP 7: Improve the Immunity of Receptor

a). Aperture size

To provide shielding, currents must flow on the surface of the enclosure. However, apertures with maximum dimensions that are much smaller than a wavelength provide very low attenuation.

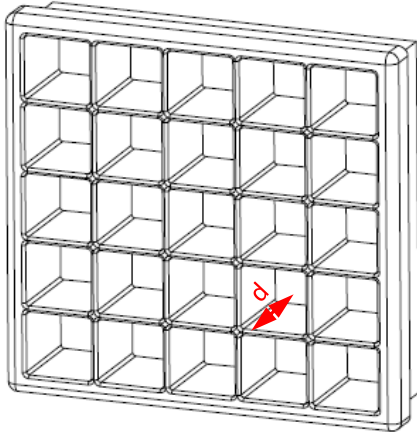


The waveguide EMI performance depends on two parameters:

- Cutoff Frequency (f_c), which determines the maximum possible frequency of effectiveness.
- Shielding Effectiveness (SE), which determines the magnitude of the EMI attenuation and is a function of frequency.

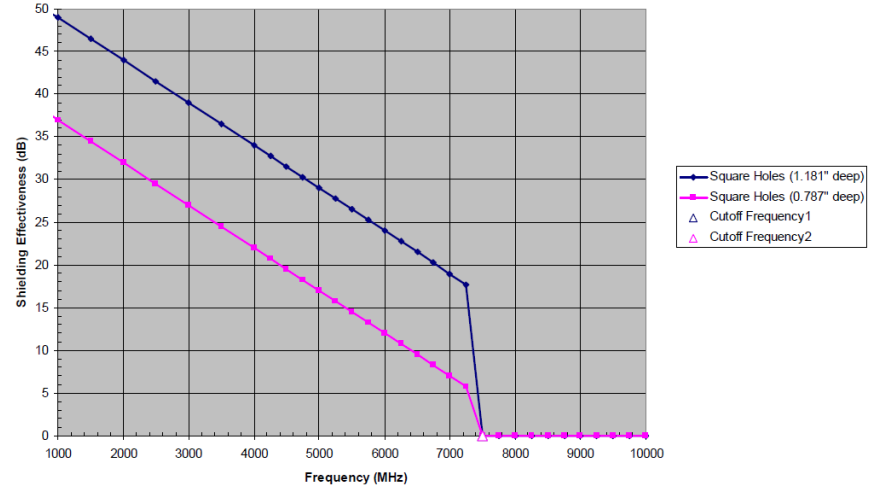
STEP 7: Improve the Immunity of Receptor

b). Increase the depth of apertures



$$SE \approx 27 \cdot \frac{d}{a} \cdot \sqrt{1 - \left(\frac{f}{f_c}\right)^2}$$

Comparative Shielding Effectiveness Plot



Panel 1:

g = 20 mm **square**

d = 30 mm deep

Number of holes = 50 holes total

f_c = 7,493 MHz

Panel 2:

g = 20 mm **square**

d = 20 mm deep

Number of holes = 50 holes total

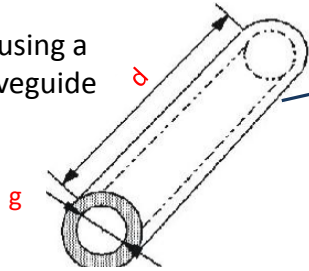
f_c = 7,493 MHz

In the case shown above, a depth change from 1.181" to 0.787" for square holes results in a 12dB change in performance up to the Cutoff Frequency

STEP 7: Improve the Immunity of Receptor

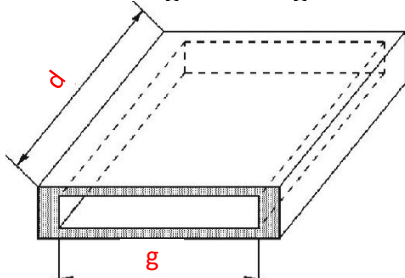
c). Aperture geometry

Derivation using a circular waveguide



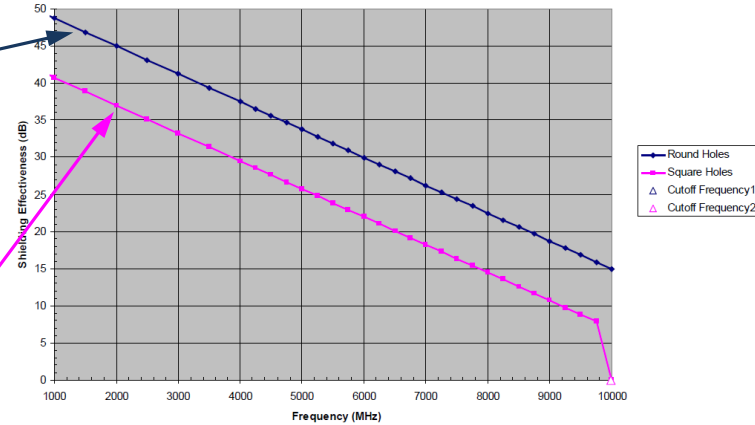
$$SE \approx 32 \cdot \frac{d}{a} \cdot \sqrt{1 - \left(\frac{f}{f_c}\right)^2}$$

Derivation using a rectangular waveguide



$$SE \approx 27 \cdot \frac{d}{a} \cdot \sqrt{1 - \left(\frac{f}{f_c}\right)^2}$$

Comparative Shielding Effectiveness Plot



Panel 1:

$g = 15$ mm **round**

$d = 15$ mm deep

Number of holes = 50 holes total

$f_c = 11,684$ MHz

Panel 2:

$g = 15$ mm **square**

$d = 15$ mm deep

Number of holes = 50 holes total

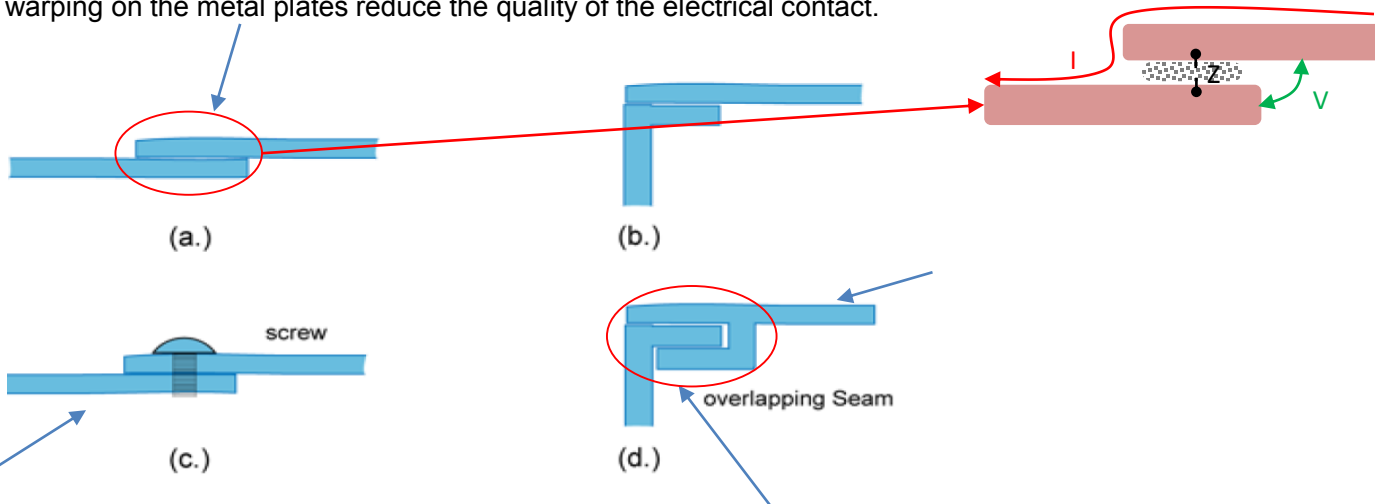
$f_c = 9,991$ MHz

A change from round holes to square holes reduces Shielding Effectiveness by approximately 8dB.

STEP 7: Improve the Immunity of Receptor

d). Seam shape

Simply pressed metal surfaces rarely provide sufficiently reliable contact at high frequencies. Surface oxidation, corrosion and warping on the metal plates reduce the quality of the electrical contact.

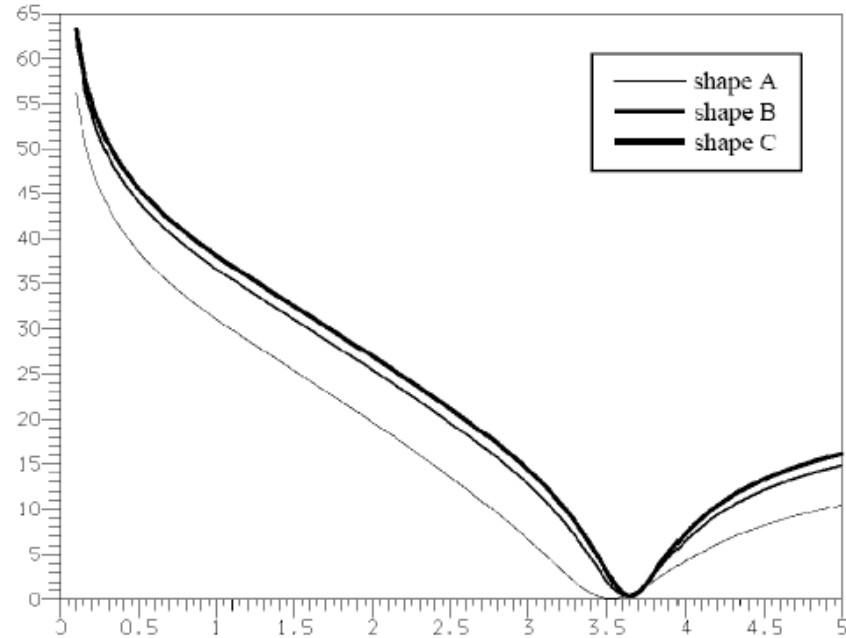
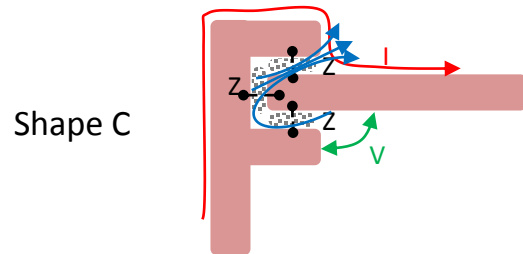
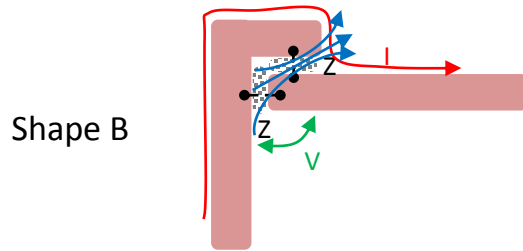
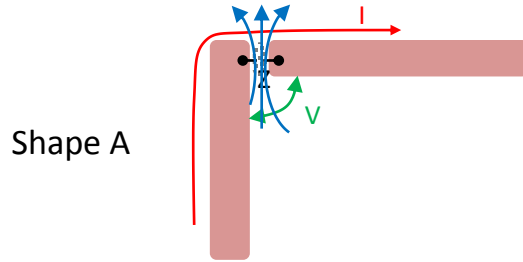


Screws or rivets can provide a good electrical contact, but they do not necessarily improve the connection at locations between fasteners.

Overlapping both sides of the plates reduces the impedance of seams.

STEP 7: Improve the Immunity of Receptor

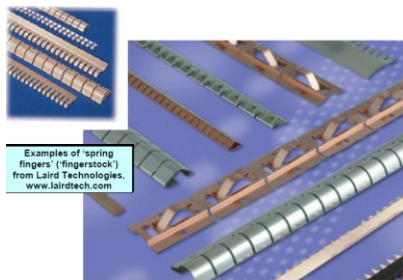
d). Seam shape



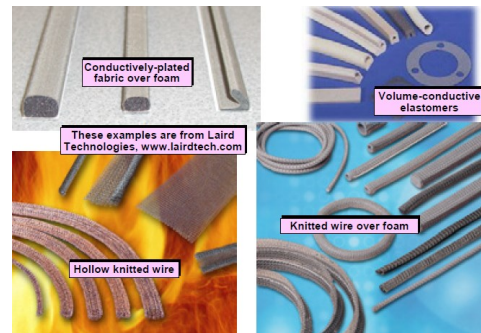
Slot resonant at 3.6GHz, SE at 5 cm away from the slot

STEP 7: Improve the Immunity of Receptor

d). Seam shape



Finger stock or gaskets have the best performance to reduce the impedance of seams



STEP 7: Improve the Immunity of Receptor

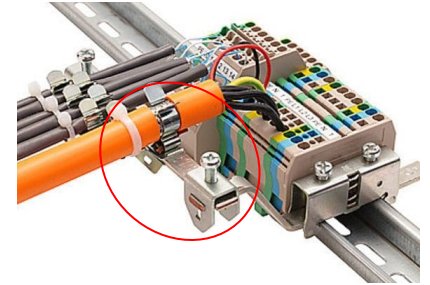
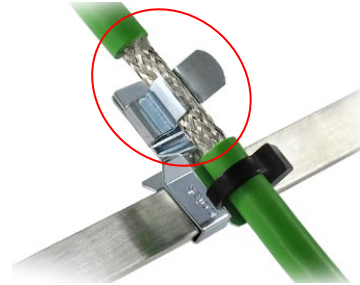
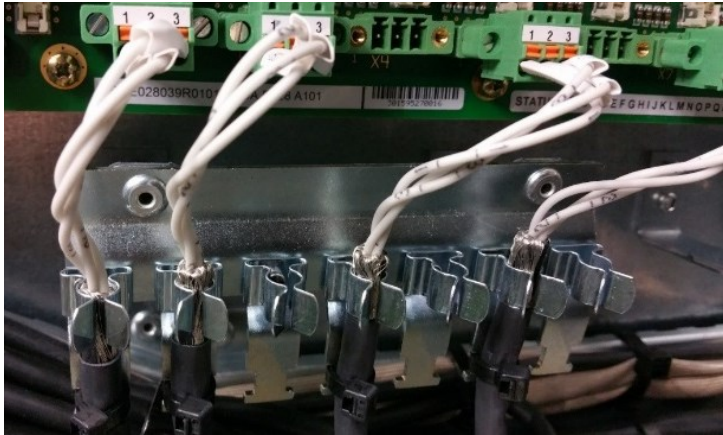
e). Cable penetration

An unshielded, unfiltered wire penetrating can completely eliminate any shielding benefit.

The wire/enclosure pair is often a very efficient antenna at relatively low frequencies.

Any wires penetrating the enclosure should:

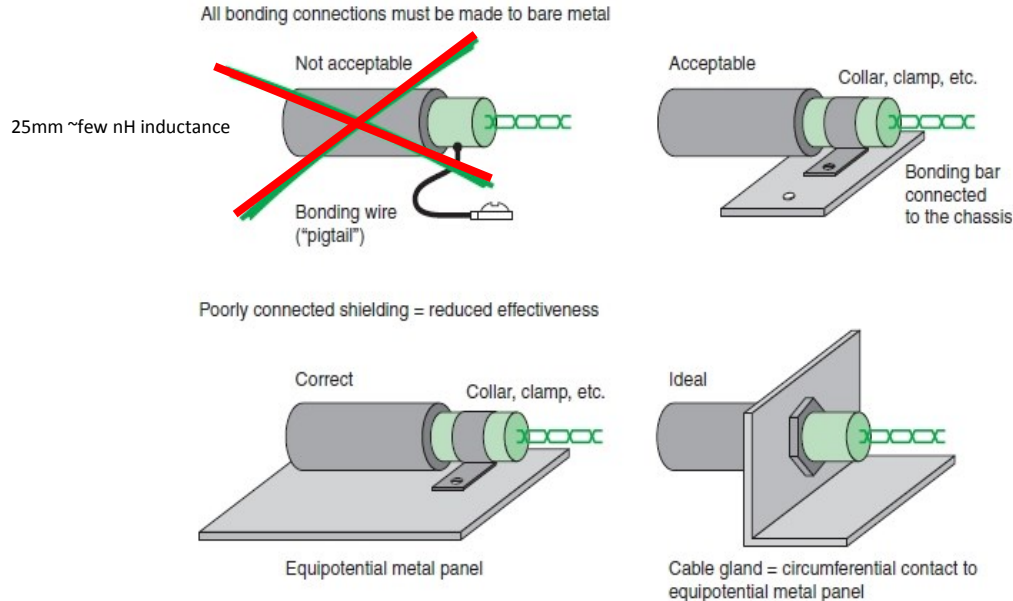
- a.) be well-shielded, or
- b.) held to the same potential as the enclosure at all frequencies that may be a radiation problem.



STEP 7: Improve the Immunity of Receptor

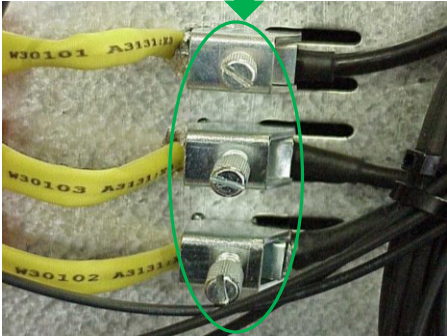
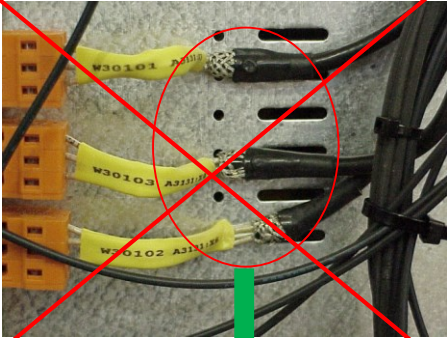
e). Cable penetration

- The cable screen connection is very important for the HF performance.
- In order to provide a low-inductance connection to the shielded enclosure the ground contact should always be effective 360 around the cable termination.

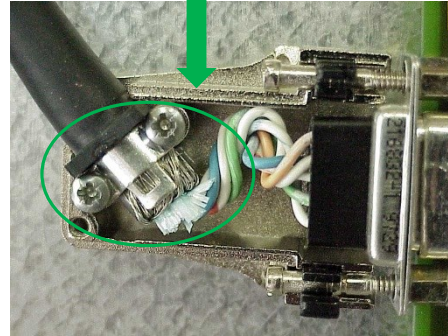
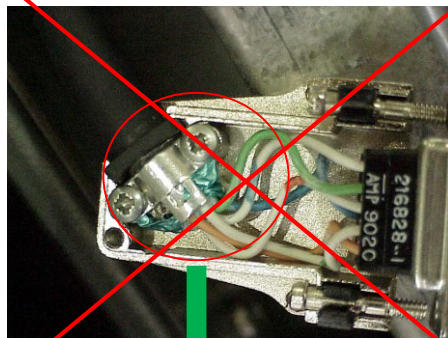


STEP 7: Improve the Immunity of Receptor

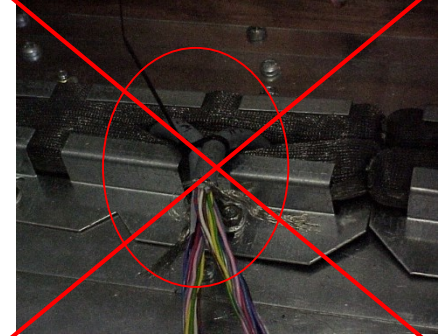
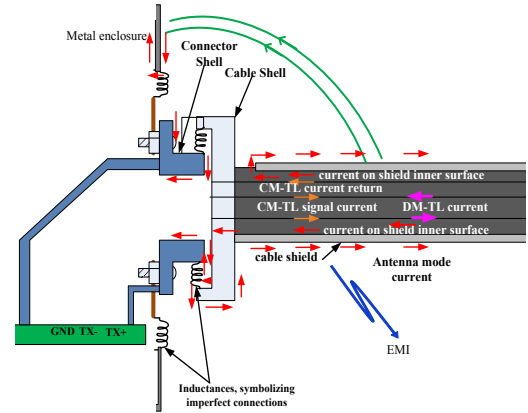
e). Cable penetration



- Shieldings should be mounted to the local ground.



- The isolation around shielding has to be removed.
- The cables should be twisted



- Shieldings should be mounted to the local ground.

STEP 7: Improve the Immunity of Receptor

f). Which end to terminate the screen?

Termination at one end:

- Moderate high-frequency protection; as the effectiveness of the screening is reduced above the resonant frequency of the cable.
- Protection against low-frequency electric field.



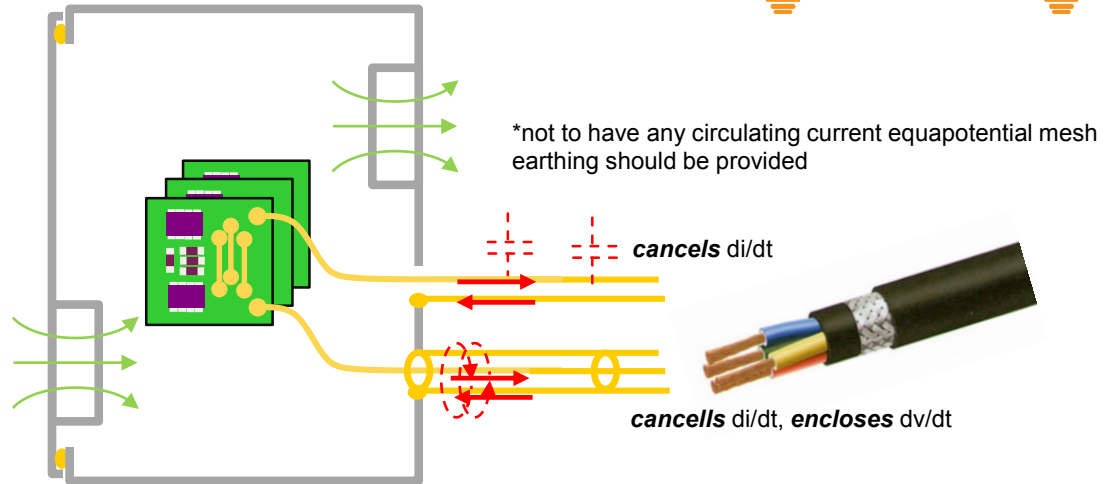
Termination at both end:

- It gives a very good protection against the most severe common mode interference (HF) even at the resonant frequency the improvement remains excellent.
- At low frequency a current may flow in the screen as a result of magnetic fields within the area of the cable. These currents can crosstalk to the interior pair.



No termination:

- No protection, just cost.



STEP 7: Improve the Immunity of Receptor

g). Corrosion

- Galvanically compatible materials are those that are:
 - For harsh environments
 - Outdoors, high humidity/salt
 - Typically design for < 0.15V difference
 - For normal environments
 - Storage in warehouses, no-temperature/humidity control
 - Typically < 0.25V difference

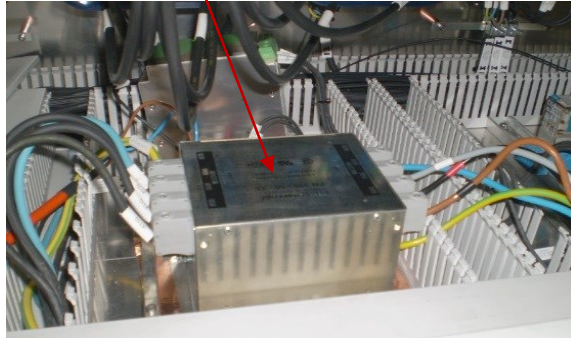
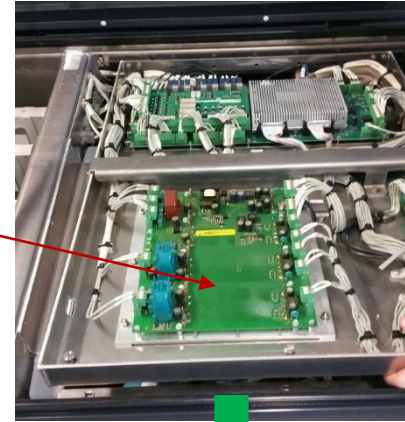
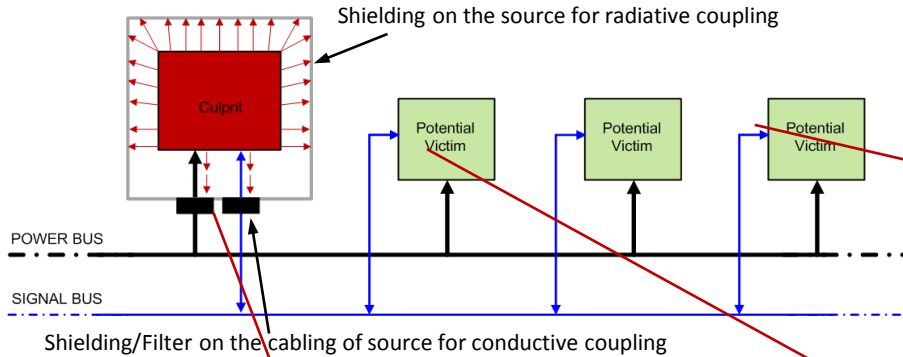
- For controlled environments
 - Temperature/humidity controlled
 - Typically design for < 0.50V difference
- Mitigation of Galvanic Corrosion
 - Choosing metals with the least potential difference
 - Finishes, such as MIL-C-5541, Class 3 using minimal dip immersion

Metallurgical Category	Anodic Index (V)
Gold, Wrought Platinum, Graphite Carbon	0.00
Rhodium Plating	0.10
Silver, High-Silver Alloys	0.15
Nickel, Nickel-Copper Alloys, Titanium, Titanium Alloys, Monel	0.30
Beryllium Copper, Low Brasses or Bronzes, Silver Solder, Copper, Ni-Cr Alloys, Austenitic Corrosion-Resistant Steels, Most Chrome-Moly Steels, Specialty High-Temp Stainless Steels	0.35
Commercial Yellow Brasses and Bronzes	0.40
High Brasses and Bronzes, Naval Brass, Muntz Metal	0.45
18% Cr-type Corrosion Resistant Steels, Common 300 Series Stainless Steels	0.50
Chromium or Tin Plating, 12% Cr type Corrosion Resistant Steels, Most 400 Series Stainless Steels	0.60
Tin-Lead Solder, Terneplate	0.65
Lead, High-Lead Alloys	0.70
Wrought 2000 Series Aluminum Alloys	0.75
Wrought Gray or Malleable Iron, Plain Carbon and Low-Alloy Steels, Armco Iron, Cold-Rolled Steel	0.85
Wrought Aluminum Alloys (except 2000 series cast Al-Si alloys), 6000 Series Aluminum	0.90
Cast aluminum Alloys (other than Al-Si), Cadmium Plating	0.95
Hot-Dip Galvanized or Electro-Galvanized Steel	1.20
Wrought Zinc, Zinc Die Casting Alloys	1.25
Wrought and Cast Magnesium Alloys	1.75
Beryllium	1.85

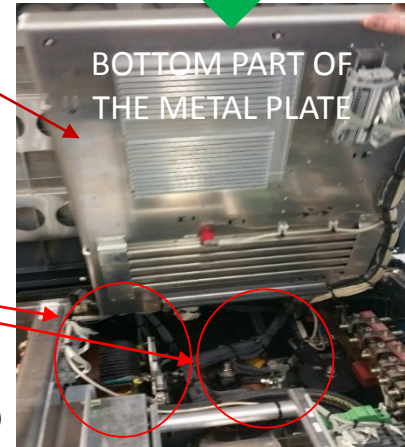
If large contact voltages occur, the more anodic material will eventually be destroyed. To prevent this problem, either the gasket material or mating surface, or both, will need to be plated with a material.

STEP 8: Break the Coupling Path

a). Prevent radiated/conducted interference on culprit side



filtering (for conducted coupling)



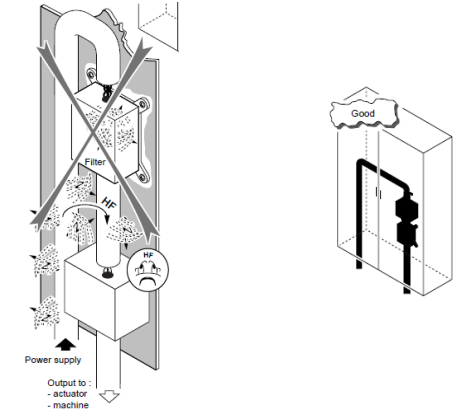
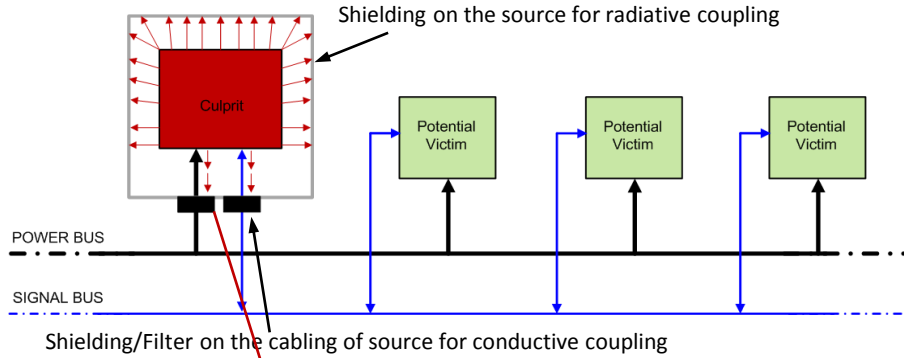
BOTTOM PART OF THE METAL PLATE

Chokes

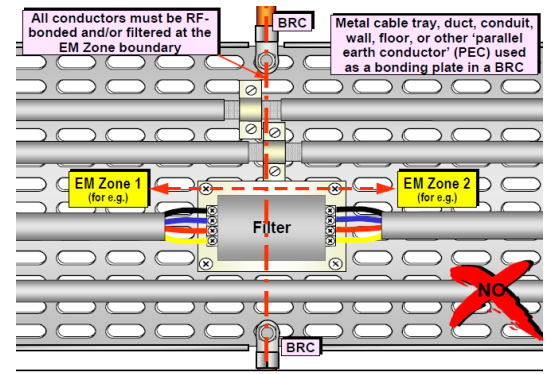
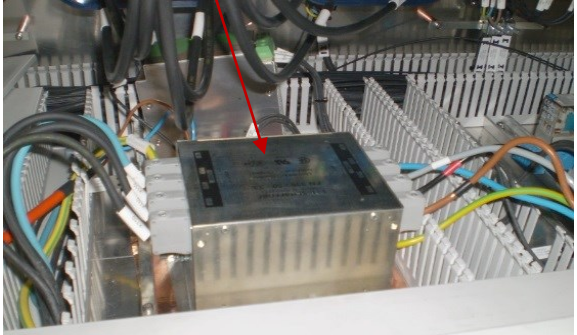
shielding (for radiated coupling)

STEP 8: Break the Coupling Path

a). Prevent radiated/conducted interference on culprit side

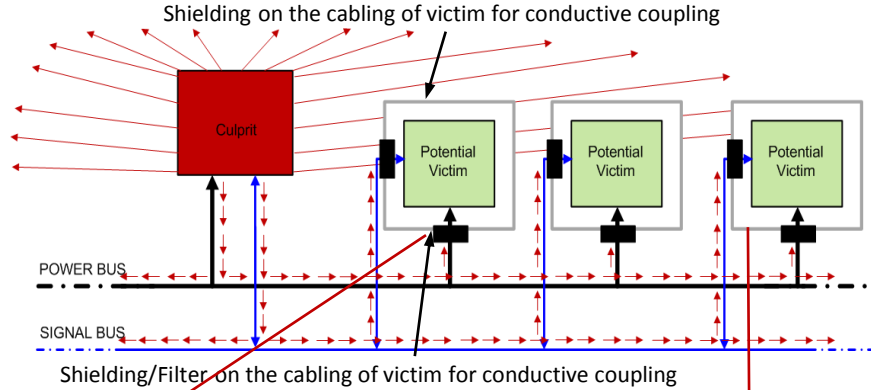


• Filters shouldn't be "bypassed" by input/output cables

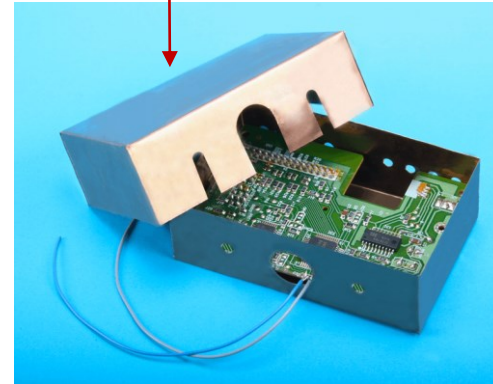


STEP 8: Break the Coupling Path

b). Prevent radiated/conducted interference on victim side



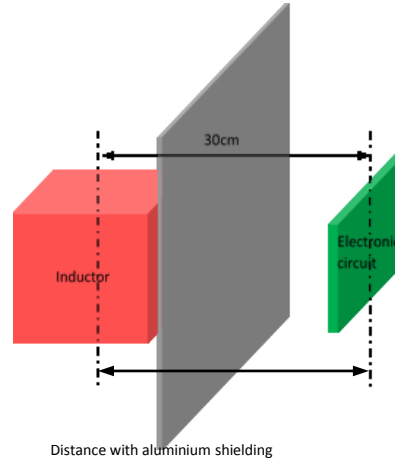
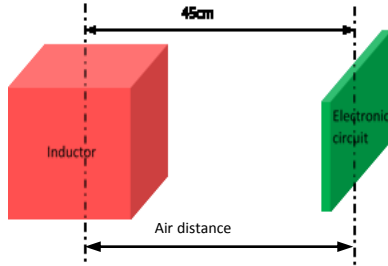
86 filtering (for conducted coupling)



shielding (for radiated coupling)

STEP 8: Break the Coupling Path

c). Spacing



$$E \propto I \cdot f^2 \cdot A \cdot \left(\frac{1}{r}\right)$$



For the magnetic components, it's required to have enough distance for electrical and magnetic clearance. It's not allowed to have any metallic structure within the magnetic clearance area not induce any unwanted currents in nearby metallic geometries.

→ Distance to small metallic parts $d > D/2$ (D : coil diameter)

→ Distance to large geometries $d > D$ (rules of thumb)

STANDARDS AND REGULATIONS

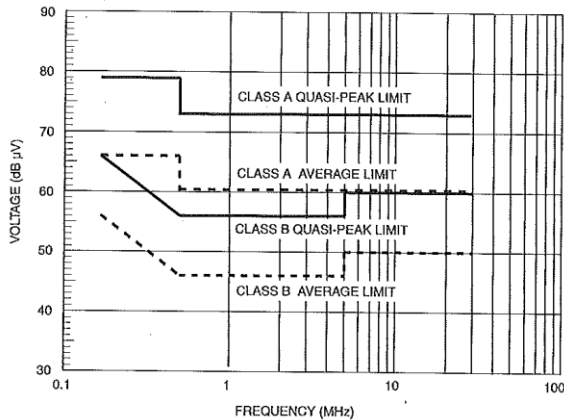
Outline

- Introduction
- Overview on Electromagnetic Basics
- Coupling Mechanisms
- Design Process
- **Standards and Regulations**
- Summary

Conducted vs. Radiated Emission Limits

Conducted

FCC/CISPR Conducted Emission Limits

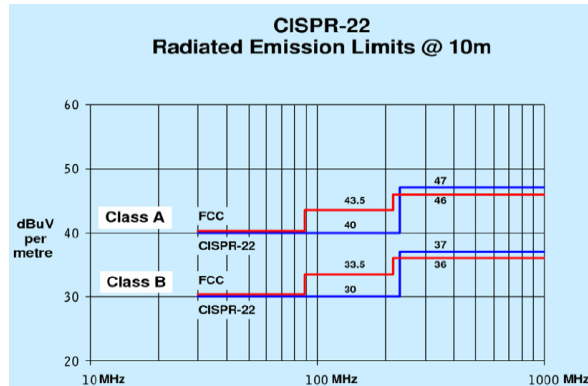


- FCC and CISPR standards the same

Radiated

FCC/CISPR Radiated Emission Limits

Measured at 10m



- FCC and CISPR standards somewhat different
- FCC B (consumer) much more stringent than FCC A (commercial, industrial, and business)

Electromagnetic Compatibility Standards

For Immunity Requirements

IEC61000-2-4
IEC61800-3-2
IEC61000-4-3
IEC61000-4-6

- **IEC61000-2-4:** LV – LF THD, individual harmonic orders, voltage unbalance etc.
- **IEC61800-3-2:** MV – LF THD, individual harmonic orders, voltage unbalance etc.
- **IEC61000-4-3:** LV – HF, against electromagnetic fields
- **IEC61000-4-6:** LV – HF, against electromagnetic fields

Electromagnetic Compatibility Standards

For Conducted Emissions

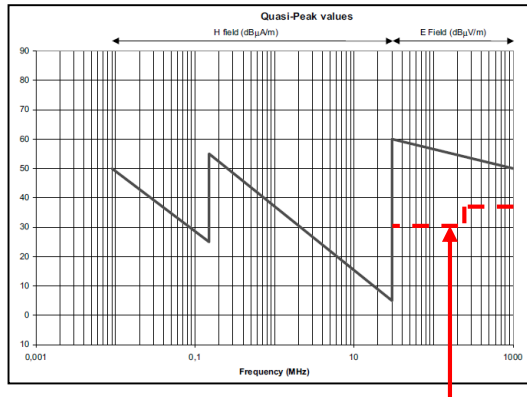
	THDv
<ul style="list-style-type: none">IEC61000-2-4IEC61800-3-2IEC61000-3-2IEC61000-3-7 <ul style="list-style-type: none">IEC61000-2-4: Industrial and non-public networks.IEC61800-3-2: LV and MV voltage fluctuations.IEC61800-3-2: Limits for main terminal disturbance.IEC61000-3-2: Harmonics and interharmonics.IEC61000-3-7: MV- Voltage fluctuations.	
<ul style="list-style-type: none">IEC61000-3-4IEC61000-3-12 <ul style="list-style-type: none">Public networks up to 600VTHD and PWHd up to:<ul style="list-style-type: none">IEC61000-3-4 <16AIEC61000-3-12 < 75A	THDi

Electromagnetic Compatibility Standards

For Radiated Emissions

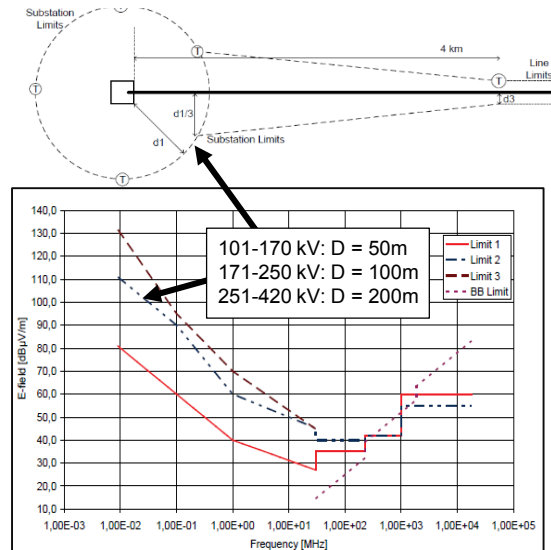
- For HV/high power converter installations there is no truly applicable standard. Directives from **IEC61800-3-2** can be followed.
- **EN 50121** is partly relevant, **Cigre 391** is relevant guideline.

EN50121 Standard for railway substation,
Limit 10m outside outer fence



For comparison, 10m requirement
for domestic environment

Cigre 391 Guide for HV/MV substations



Standards & Regulations IEC61000-2-12

Odd harmonic not multiples of 3		Odd harmonics multiples of 3 (note)		Even harmonics	
Harmonic order (h)	Harmonic voltage (%)	Harmonic order (h)	Harmonic voltage (%)	Harmonic order (h)	Harmonic voltage (%)
5	6	3	5	2	2
7	5	9	1,5	4	1
11	3,5	15	0,4	6	0,5
13	3	21	0,3	8	0,5
$17 \leq h \leq 49$	$2,27 \times (17/h) - 0,27$	$21 \leq h \leq 45$	0,2	$10 \leq h \leq 50$	$0,25 \times (10/h) + 0,25$

Note: The levels indicated through even harmonics multiples of three are applied to the homopolar harmonics. So this, in a 3-phase distribution line without neutral cable with no load connected between a phase and ground, the value of the harmonics order 3 and 9 can be lower enough than compatibility levels, depending on the distribution line imbalance.

SUMMARY

Outline

- Introduction
- Overview on Electromagnetic Basics
- Coupling Mechanisms
- Design Process
- Standards and Regulations
- **Summary**

SUMMARY

- EMI changes with → *f, I, A, 1/r*

$$E \propto f^2 \cdot \frac{1}{r} \cdot I \cdot A$$

- **EMC design steps:**

- **Step 1:** Identify the systems requirements (for harmonics requirements)
- **Step 2:** Identify the installation environment (for emission and radiation levels)
- **Step 3:** Choose right type of topology (important for low order harmonics)
- **Step 4:** Use right type of control to suppress the harmonics
- **Step 5:** Minimize the switching path enclosed area
- **Step 6:** Identify source and victims
- **Step 7:** Place the source and victims based on zone concept
- **Step 8:** Classify and separate the cables
- **Step 9:** Make a cable routing plan
- **Step 10:** Make installation and grounding plan (grounding, earthing, equipotential bonding, shielding)
- **Step 11:** Separate the clean and dirty grounding
- **Step 12:** Use right type of apertures and keep sensitive circuits away from the apertures
- **Step 13:** Identify if /when filter or shielding are required

Thank You for Your Attention



Ilknur Colak
Maschinenfabrik Reinhausen
ilknur.colak@gmail.com

REFERENCES

- <http://www.dbicorporation.com>
- http://www.i-gard.com/Downloads/Ask_An_Expert/System%20Grounding.pdf
- http://www.digikey.ch/Web%20Export/Supplier%20Content/Laird_776/PDF/Laird_EMI_RuleofThumb_Calculating_Aperture_Size.pdf?redirected=1
- EMI, RFI, and Shielding Concepts, <http://www.analog.com/media/en/training-seminars/tutorials/MT-095.pdf>
- ABB Grounding and cabling of the drive system – Variable speed drives
- Siemens EMC installation guidelines / basic system requirements, https://cache.industry.siemens.com/dl/files/658/60612658/att_77711/v1/EMV_01_2012_en_en-US.pdf
- "Interference-free electronics" by Dr. Sten Benda. Ordering number ABB 3BSE 000877R0001, ISBN 91-44-3140-9, ISBN 0-86238-255-6.
- "Bearing Currents in AC Drive" by FIDRI and FIMOT. Set of overheads in LN database "FIDRI Document Directory" on ABB_FI01_SPK04/FI01/ABB
- "A New Reason for Bearing Current Damage in Variable Speed AC Drives" by J. Ollila, T. Hammar, J. Iisakkala, H. Tuusa. EPE 97. The European Conference on Power Electronics and Applications 8 –10 September 1997 Trondheim, Norway pp. 2.539 to 2.542.
- "On the Bearing Currents in Medium Power Variable Speed AC Drives" by J. Ollila, T. Hammar, J. Iisakkala, H. Tuusa. Proceedings of the IEEE IEDMC in Milwaukee, May 1997.
- http://www.electrical-installation.org/enwiki/Common-mode_impedance_coupling
- H. Ott, *Electromagnetic Compatibility Engineering*, John Wiley & Sons, New York, 2009.
- C. R. Paul, *Introduction to Electromagnetic Compatibility, 2nd Ed.*, Wiley Series in Microwave and Optical Engineering, 2006.
- http://chemwiki.ucdavis.edu/Physical_Chemistry/Physical_Properties_of_Matter/Atomic_and_Molecular_Properties/Magnetic_Properties
- Paul, C. R. "Frequency Response of Multiconductor Transmission Lines Illuminated by an Electromagnetic Field," EMC-18, No. 4, November – 1976, Page 183.
- Robinson, M.P. "Analytical Formulation for the Shielding Effectiveness of Enclosures with Apertures," Volume 40, No. 3, August – 1998, Page 240. Christopoulos, C. Dawson, J.F. Ganley, M.D. Marvin, A.C. Porter, S.J. Thomas, D.W.P
- Schulz, R.B. "Shielding Theory and Practice," Volume 30, No. 3, August – 1988, Page 187. Brush, D.R.